

采用 QFN 封装且具备 4.5V 至 14.5V 输入的 LMZ31503 3A 电源模块

1 特性

- 完整的集成式电源解决方案可实现小尺寸和扁平设计
- 9mm × 15mm × 2.8mm 封装
 - 与 LMZ31506 之间实现引脚兼容
- 效率高达 95%
- 0.8V 至 5.5V 的宽输出电压调节范围，基准精度为 1%
- 可选分离电源轨可实现低至 1.6V 的输入电压
- 可调开关频率 (330kHz 至 780kHz)
- 与外部时钟同步
- 可调慢速启动
- 输出电压排序/跟踪
- 电源正常输出
- 可编程欠压锁定 (UVLO)
- 过流保护 (断续模式)
- 过热保护
- 预偏置输出启动
- 工作温度范围: -40°C 至 +85°C
- 增强的热性能: 13°C/W
- 符合 EN55022 B 类辐射标准
 - 集成屏蔽电感器
- 使用 LMZ31503 并借助 [WEBENCH®](#) 电源设计器创建定制设计方案

2 应用

- 宽带和通信基础设施
- 自动化测试和医疗设备
- 紧凑型 PCI/PCI 快速接口/PXI 快速接口
- DSP 和 FPGA 负载点应用
- 高密度分布式电源系统

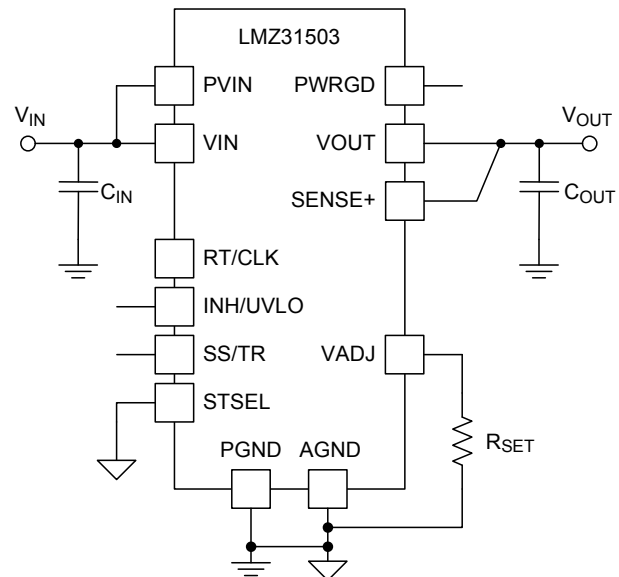
3 说明

LMZ31503 电源模块是一款易于使用的集成式电源解决方案，它在一个扁平的 QFN 封装内整合了一个带有功率 MOSFET 的 3A 直流/直流转换器、一个屏蔽式电感器和多个无源器件。此整体电源解决方案仅需 3 个外部组件，并省去了环路补偿和磁性元件选择过程。

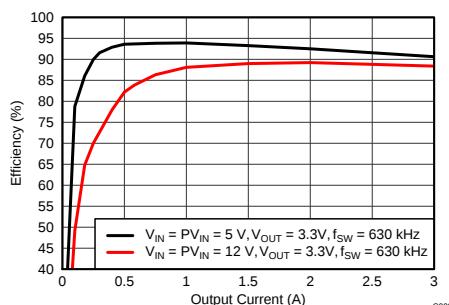
9mm x 15mm x 2.8mm QFN 封装能轻松焊接到印刷电路板上，并且可实现效率高于 95% 的紧凑型负载点设计以及结至环境的热阻抗仅为 13°C/W 的出色功率耗散。在环境温度为 85°C 且无气流的情况下，该器件可提供 3A 的满额输出电流。

LMZ31503 提供了分离式负载点设计的灵活性和功能集，非常适合为高性能 DSP 和 FPGA 供电。先进的封装技术可提供一个与标准 QFN 贴装和测试技术兼容的耐用且可靠的电源解决方案。

简化电路原理图



效率



4 Specifications

4.1 Absolute Maximum Ratings⁽¹⁾

over operating temperature range (unless otherwise noted)

		VALUE	UNIT
Input Voltage	VIN	–0.3 to 16	V
	PVIN	–0.3 to 16	V
	INH/UVLO	–0.3 to 6	V
	VADJ	–0.3 to 3	V
	PWRGD	–0.3 to 6	V
	SS/TR	–0.3 to 3	V
	STSEL	–0.3 to 3	V
	RT/CLK	–0.3 to 6	V
Output Voltage	PH	–1 to 20	V
	PH 10ns Transient	–3 to 20	V
V _{DIFF} (GND to exposed thermal pad)		–0.2 to 0.2	V
Source Current	RT/CLK	±100	μA
	PH	Current Limit	A
Sink Current	PH	Current Limit	A
	PVIN	Current Limit	A
	PWRGD	–0.1 to 5	mA
Operating Junction Temperature		–40 to 125 ⁽²⁾	°C
Storage Temperature		–65 to 150	°C
Peak Reflow Case Temperature ⁽³⁾		245 ⁽⁴⁾	°C
Maximum Number of Reflows Allowed ⁽³⁾		3 ⁽⁴⁾	
Mechanical Shock	Mil-STD-883D, Method 2002.3, 1 msec, 1/2 sine, mounted	1500	G
Mechanical Vibration	Mil-STD-883D, Method 2007.2, 20-2000Hz	20	

- (1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) See the temperature derating curves in the Typical Characteristics section for thermal information.
- (3) For soldering specifications, refer to the [Soldering Requirements for BQFN Packages](#) application note.
- (4) Devices with a date code prior to week 14 2018 (1814) have a peak reflow case temperature of 240°C with a maximum of one reflow

4.2 Thermal Information

THERMAL METRIC ⁽¹⁾		LMZ31503	UNIT
		RUQ47	
		47 PINS	
θ_{JA}	Junction-to-ambient thermal resistance ⁽²⁾	13	°C/W
ψ_{JT}	Junction-to-top characterization parameter ⁽³⁾	2.5	°C/W
ψ_{JB}	Junction-to-board characterization parameter ⁽⁴⁾	5	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.
- (2) The junction-to-ambient thermal resistance, θ_{JA} , applies to devices soldered directly to a 100 mm x 100 mm double-sided PCB with 1 oz. copper and natural convection cooling. Additional airflow reduces θ_{JA} .
- (3) The junction-to-top characterization parameter, ψ_{JT} , estimates the junction temperature, T_J , of a device in a real system, using a procedure described in JESD51-2A (sections 6 and 7). $T_J = \psi_{JT} * P_{dis} + T_T$; where P_{dis} is the power dissipated in the device and T_T is the temperature of the top of the device.
- (4) The junction-to-board characterization parameter, ψ_{JB} , estimates the junction temperature, T_J , of a device in a real system, using a procedure described in JESD51-2A (sections 6 and 7). $T_J = \psi_{JB} * P_{dis} + T_B$; where P_{dis} is the power dissipated in the device and T_B is the temperature of the board 1mm from the device.

4.3 Package Specifications

LMZ31503		UNIT
Weight		1.26 grams
Flammability	Meets UL 94 V-O	
MTBF Calculated reliability	Per Bellcore TR-332, 50% stress, $T_A = 40^\circ\text{C}$, ground benign	40.1 Mhrs

4.4 Electrical Characteristics

Over -40°C to 85°C free-air temperature, $P_{VIN} = V_{IN} = 12\text{ V}$, $V_{OUT} = 1.8\text{ V}$, $I_{OUT} = 3\text{ A}$,

$C_{IN1} = 2 \times 22\text{ }\mu\text{F}$ ceramic, $C_{IN2} = 68\text{ }\mu\text{F}$ poly-tantalum, $C_{OUT1} = 4 \times 47\text{ }\mu\text{F}$ ceramic (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
I _{OUT}	Output current	T _A = 85°C, natural convection		0		3	A
V _{IN}	Input bias voltage range	Over I _{OUT} range		4.5		14.5	V
P _{VIN}	Input switching voltage range	Over I _{OUT} range		1.6 ⁽¹⁾		14.5	V
UVLO	VIN Undervoltage lockout	VIN = increasing		4.0		4.5	V
		VIN = decreasing		3.5	3.85		
V _{OUT(adj)}	Output voltage adjust range	Over I _{OUT} range		0.8		5.5	V
V _{OUT}	Set-point voltage tolerance	T _A = 25°C, I _{OUT} = 0A				±1.0% ⁽²⁾	
	Temperature variation	-40°C ≤ T _A ≤ +85°C, I _{OUT} = 0A				±0.3%	
	Line regulation	Over P _{VIN} range, T _A = 25°C, I _{OUT} = 0A				±0.1%	
	Load regulation	Over I _{OUT} range, T _A = 25°C				±0.1%	
	Total output voltage variation	Includes set-point, line, load, and temperature variation				±1.5% ⁽²⁾	
η	Efficiency	P _{VIN} = V _{IN} = 12 V I _O = 1.5 A	V _{OUT} = 5V, f _{SW} = 780kHz	91.5 %			
			V _{OUT} = 3.3V, f _{SW} = 630kHz	89.0 %			
			V _{OUT} = 2.5V, f _{SW} = 480kHz	86.9 %			
			V _{OUT} = 1.8V, f _{SW} = 480kHz	85.2 %			
			V _{OUT} = 1.2V, f _{SW} = 480kHz	82.1 %			
			V _{OUT} = 0.8V, f _{SW} = 330kHz	78.7 %			
		P _{VIN} = V _{IN} = 5 V I _O = 1.5 A	V _{OUT} = 3.3V, f _{SW} = 630kHz	93.3 %			
			V _{OUT} = 2.5V, f _{SW} = 480kHz	91.4 %			
			V _{OUT} = 1.8V, f _{SW} = 480kHz	88.8 %			
			V _{OUT} = 1.2V, f _{SW} = 480kHz	85.2 %			
			V _{OUT} = 0.8V, f _{SW} = 330kHz	81.8 %			
Output voltage ripple		20 MHz bandwidth		35		mV _{PP}	
I _{LIM}	Overcurrent threshold			5.8		A	

- (1) The minimum P_{VIN} voltage is 1.6V or ($V_{OUT} + 0.7\text{ V}$), whichever is greater. V_{IN} must be greater than 4.5V.
- (2) The stated limit of the set-point voltage tolerance includes the tolerance of both the internal voltage reference and the internal adjustment resistor. The overall output voltage tolerance will be affected by the tolerance of the external R_{SET} resistor.

Electrical Characteristics (continued)

Over -40°C to 85°C free-air temperature, $P_{VIN} = V_{IN} = 12\text{ V}$, $V_{OUT} = 1.8\text{ V}$, $I_{OUT} = 3\text{ A}$,

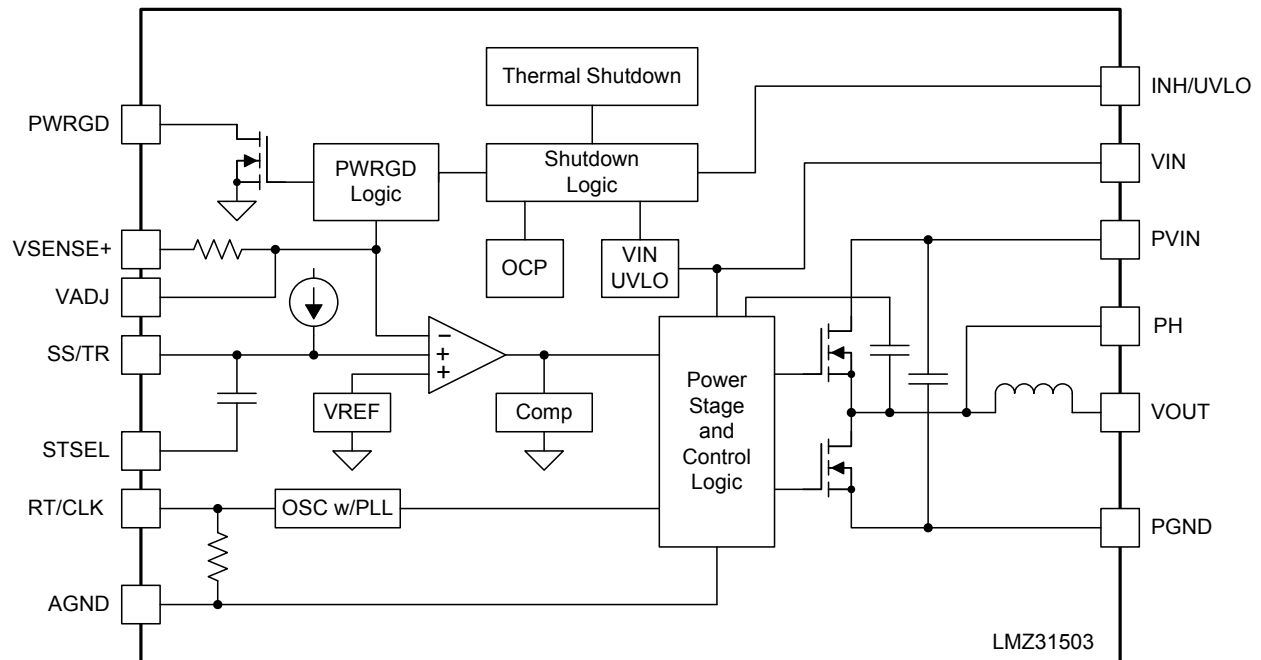
$C_{IN1} = 2 \times 22\text{ }\mu\text{F}$ ceramic, $C_{IN2} = 68\text{ }\mu\text{F}$ poly-tantalum, $C_{OUT1} = 4 \times 47\text{ }\mu\text{F}$ ceramic (unless otherwise noted)

PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT
Transient response	1.0 A/ μs load step from 50 to 100% $I_{OUT(max)}$	Recovery time		190		μs
		V_{OUT} over/undershoot		35		mV
V_{INH-H} — Inhibit Control	Inhibit High Voltage		1.30		Open ⁽³⁾	V
V_{INH-L}	Inhibit Low Voltage		-0.3		1.05	
INH Input current	$INH < 1.1\text{ V}$			-1.15		μA
INH Hysteresis current	$INH > 1.26\text{ V}$			-3.4		μA
$I_{I(stby)}$ Input standby current	INH pin to AGND			2	4	μA
Power Good	PWRGD Thresholds	V_{OUT} rising	Good	94%		
			Fault	109%		
	V_{OUT} falling		Fault	91%		
			Good	106%		
PWRGD Low Voltage	$I(PWRGD) = 2\text{ mA}$				0.3	V
f_{SW} Switching frequency	Over V_{IN} and I_{OUT} ranges, RT/CLK pin OPEN		270	330	390	kHz
f_{CLK} Synchronization frequency	CLK Control		330		780	kHz
V_{CLK-H} CLK High-Level Threshold			2.0		5.5	V
V_{CLK-L} CLK Low-Level Threshold					0.8	V
D_{CLK} CLK Duty cycle			20%		80%	
Thermal Shutdown	Thermal shutdown		160	175		°C
	Thermal shutdown hysteresis			10		°C
C_{IN} External input capacitance	Ceramic		22 ⁽⁴⁾			μF
	Non-ceramic		68 ⁽⁴⁾			
C_{OUT} External output capacitance	Ceramic		200 ⁽⁵⁾		1500	μF
	Non-ceramic				5000	
	Equivalent series resistance (ESR)				35	m Ω

- (3) This control pin has an internal pullup. If this pin is left open circuit, the device operates when input power is applied. A small low-leakage (<300 nA) MOSFET is recommended for control. See the application section for further guidance.
- (4) A minimum of 68 μF of polymer tantalum and/or ceramic external capacitance is required across the input (V_{IN} and PGND connected) for proper operation. Locate the capacitor close to the device. See [Table 5](#) for more details. When operating with split V_{IN} and P_{VIN} rails, place 4.7 μF of ceramic capacitance directly at the V_{IN} pin to PGND.
- (5) The amount of required output capacitance varies depending on the output voltage (see [Table 3](#)). The amount of required capacitance must include ceramic capacitance. Locate the capacitance close to the device. Adding additional capacitance close to the load improves the response of the regulator to load transients. See [Table 3](#) and [Table 5](#) more details.

5 Device Information

Functional Block Diagram



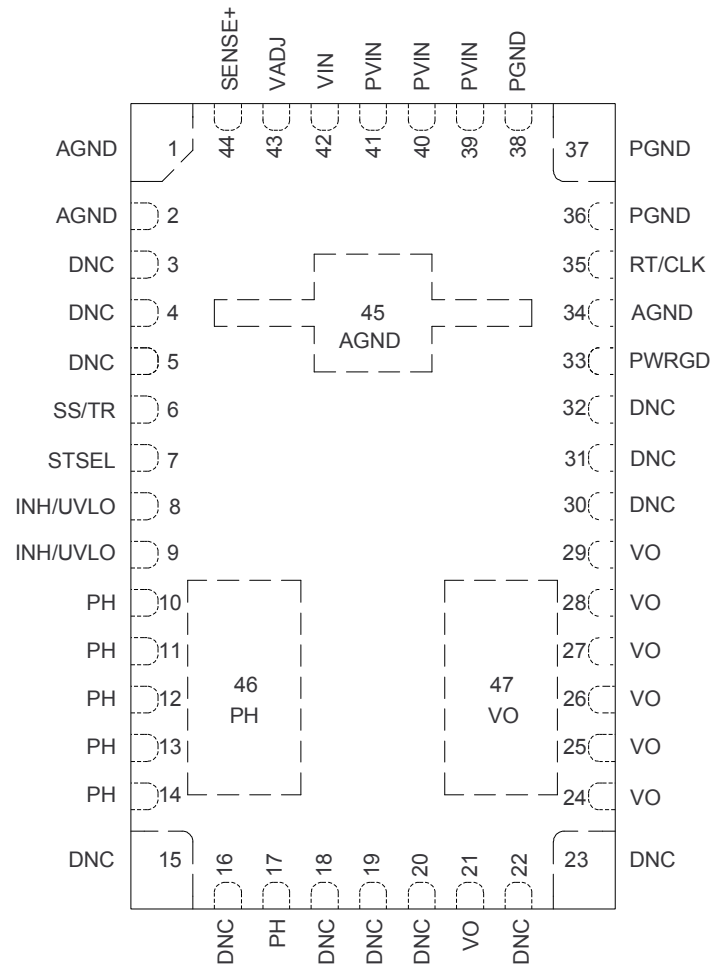
Pin Descriptions

TERMINAL		DESCRIPTION
NAME	NO.	
AGND	1	Zero VDC reference for the analog control circuitry. Connect AGND to PGND at a single point. Connect near the output capacitors. See for a recommended layout.
	2	
	34	
	45	
INH/UVLO	8	Inhibit and UVLO adjust pin. Use an open drain or open collector output logic to control the INH function. A resistor divider between this pin, AGND and VIN adjusts the UVLO voltage. Tie both pins together when using this control.
	9	
DNC	3	Do Not Connect. Do not connect these pins to AGND, to another DNC pin, or to any other voltage. These pins are connected to internal circuitry. Each pin must be soldered to an isolated pad.
	4	
	5	
	15	
	16	
	18	
	19	
	20	
	22	
	23	
	30	
	31	
	32	
PGND	36	Common ground connection for the PVIN, VIN, and VOUT power connections. See for a recommended layout.
	37	
	38	
PH	10	Phase switch node. These pins should be connected to a small copper island under the device for thermal relief. Do not place any external component on this pin or tie it to a pin of another function.
	11	
	12	
	13	
	14	
	17	
	46	
PWRGD	33	Power good fault pin. Asserts low if the output voltage is low. A pull-up resistor is required.
PVIN	39	Input switching voltage. This pin supplies voltage to the power switches of the converter. See for a recommended layout.
	40	
	41	
RT/CLK	35	This pin automatically selects between RT mode and CLK mode. An external timing resistor adjusts the switching frequency of the device. In CLK mode, the device synchronizes to an external clock.
SENSE+	44	Remote sense connection. Connect this pin to VOUT at the load for improved regulation. This pin must be connected to VOUT at the load, or at the module pins.
SS/TR	6	Slow-start and tracking pin. Connecting an external capacitor to this pin adjusts the output voltage rise time. A voltage applied to this pin allows for tracking and sequencing control.
STSEL	7	Slow-start or track feature select. Connect this pin to AGND to enable the internal SS capacitor with a SS interval of approximately 1.1 ms. Leave this pin open to enable the TR feature.
VADJ	43	Connecting a resistor between this pin and AGND sets the output voltage.
VIN	42	Input bias voltage pin. Supplies the control circuitry of the power converter. See for a recommended layout.

Pin Descriptions (continued)

TERMINAL		DESCRIPTION
NAME	NO.	
VOUT	21	Output voltage. Connect output capacitors between these pins and PGND.
	24	
	25	
	26	
	27	
	28	
	29	
	47	

**RUQ PACKAGE
47 PINS
(TOP VIEW)**



6 Typical Characteristics (PVIN = VIN = 12 V) ⁽¹⁾ ⁽²⁾

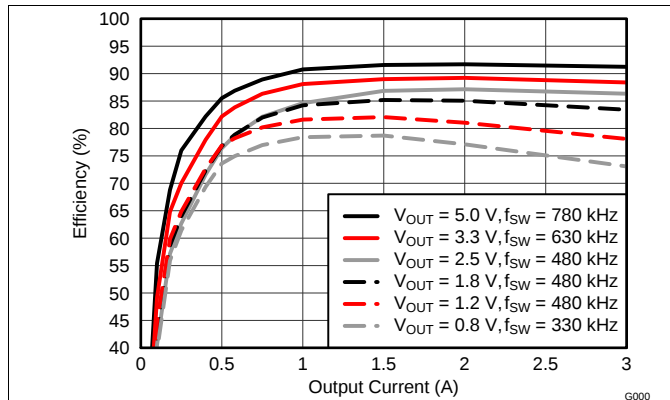


Figure 1. Efficiency vs. Output Current

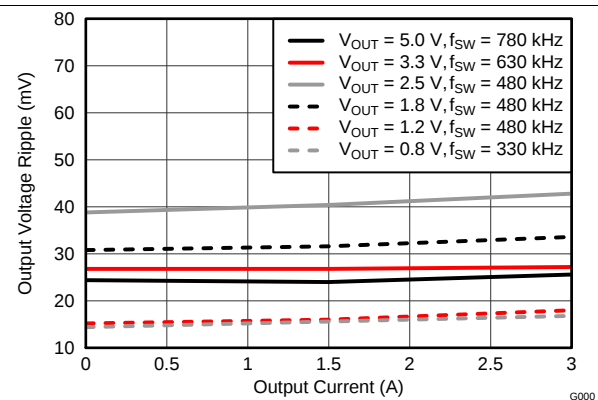


Figure 2. Voltage Ripple vs. Output Current

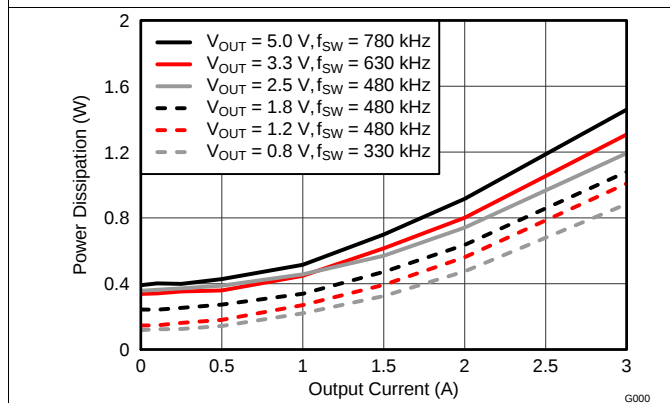


Figure 3. Power Dissipation vs. Output Current

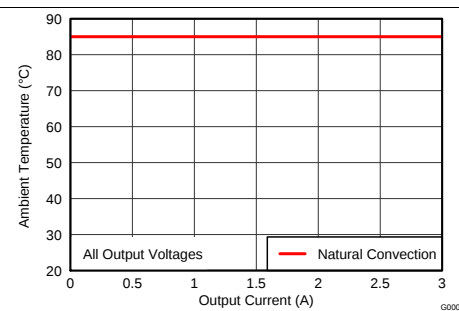


Figure 4. Safe Operating Area

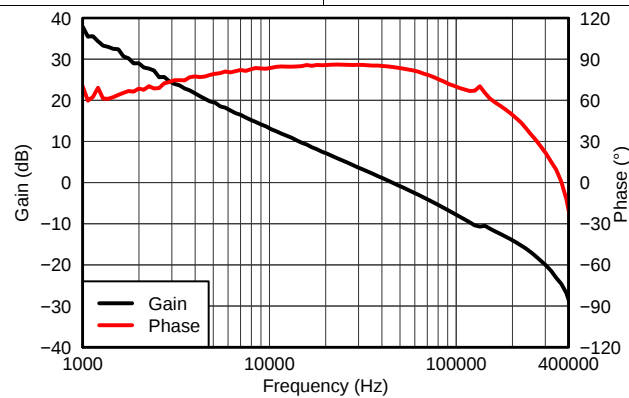


Figure 5. $V_{OUT} = 1.8\text{ V}$, $I_{OUT} = 3\text{ A}$, $C_{OUT1} = 100\text{ }\mu\text{F}$ ceramic, $C_{OUT2} = 100\text{ }\mu\text{F}$ ceramic, $f_{SW} = 480\text{ kHz}$

- (1) The electrical characteristic data has been developed from actual products tested at 25°C. This data is considered typical for the converter. Applies to [Figure 1](#), [Figure 2](#), and [Figure 3](#).
- (2) The temperature derating curves represent the conditions at which internal components are at or below the manufacturer's maximum operating temperatures. Derating limits apply to devices soldered directly to a 100 mm × 100 mm double-sided PCB with 1 oz. copper. Applies to [Figure 4](#).

7 Typical Characteristics (PVIN = VIN = 5 V) ^{(1) (2)}

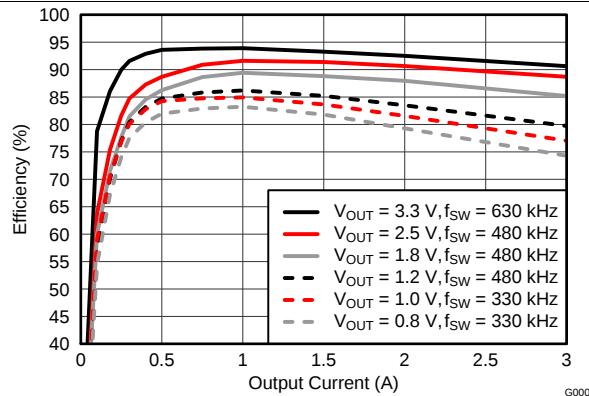


Figure 6. Efficiency vs. Output Current

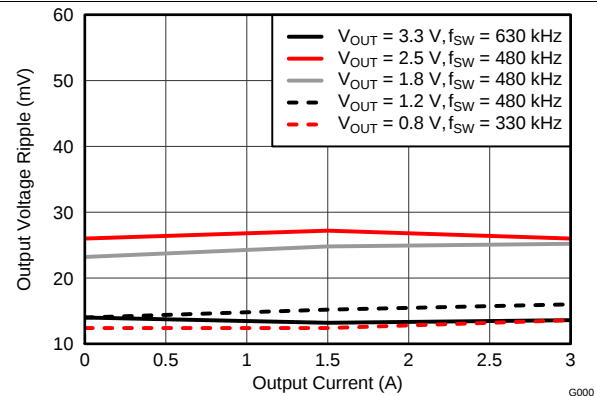


Figure 7. Voltage Ripple vs. Output Current

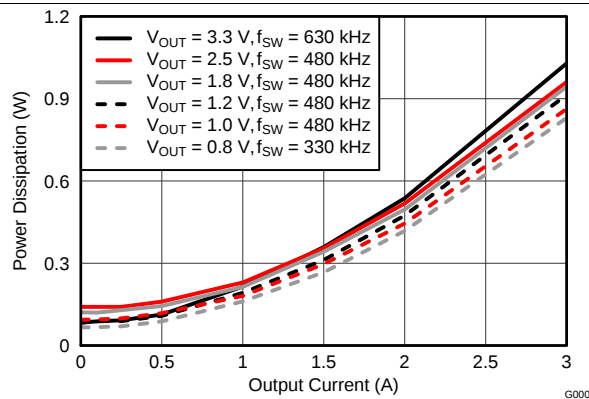


Figure 8. Power Dissipation vs. Output Current

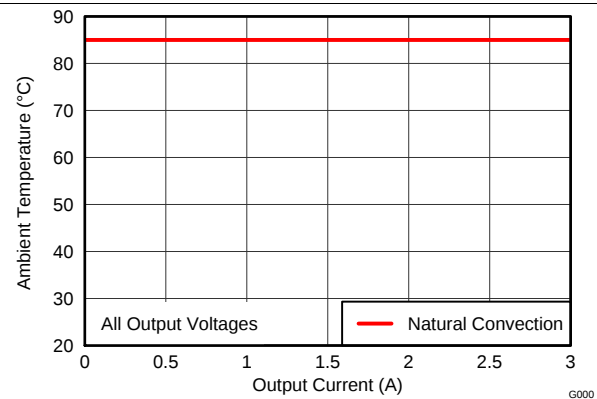


Figure 9. Safe Operating Area

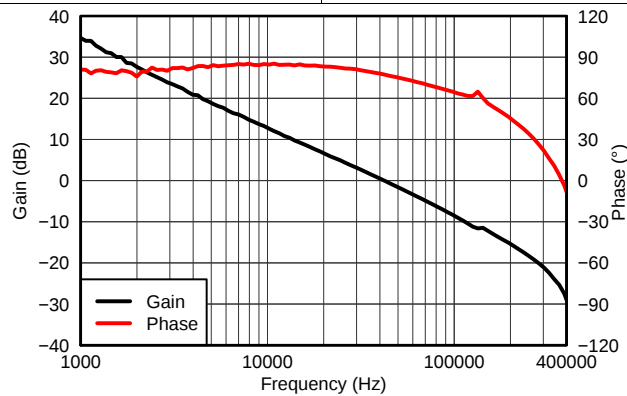


Figure 10. V_{OUT}=1.8 V, I_{OUT}=3 A, C_{OUT1}= 100 μ F ceramic, C_{OUT2}= 100 μ F ceramic, f_{SW}= 480 kHz

- (1) The electrical characteristic data has been developed from actual products tested at 25°C. This data is considered typical for the converter. Applies to [Figure 6](#), [Figure 7](#), and [Figure 8](#).
- (2) The temperature derating curves represent the conditions at which internal components are at or below the manufacturer's maximum operating temperatures. Derating limits apply to devices soldered directly to a 100 mm $\times$ 100 mm double-sided PCB with 1 oz. copper. Applies to [Figure 9](#).

8 Typical Characteristics (PVIN = 12 V, VIN = 5 V) ⁽¹⁾ ⁽²⁾

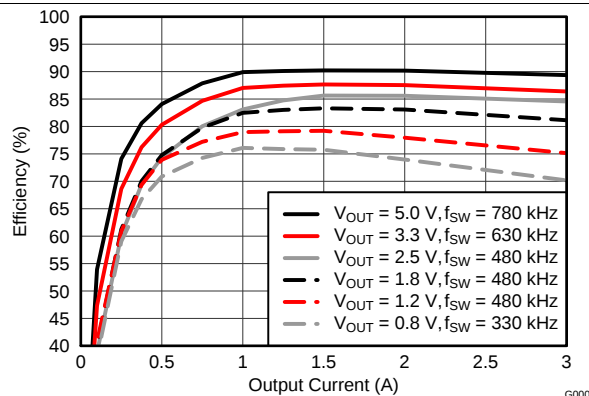


Figure 11. Efficiency vs. Output Current

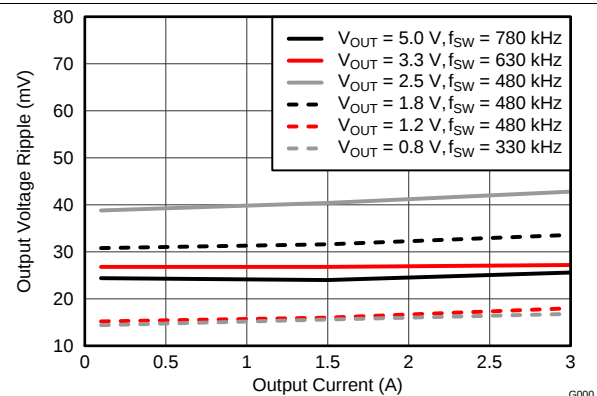


Figure 12. Voltage Ripple vs. Output Current

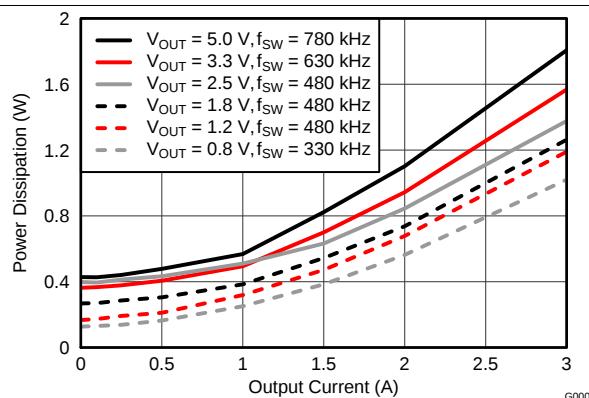


Figure 13. Power Dissipation vs. Output Current

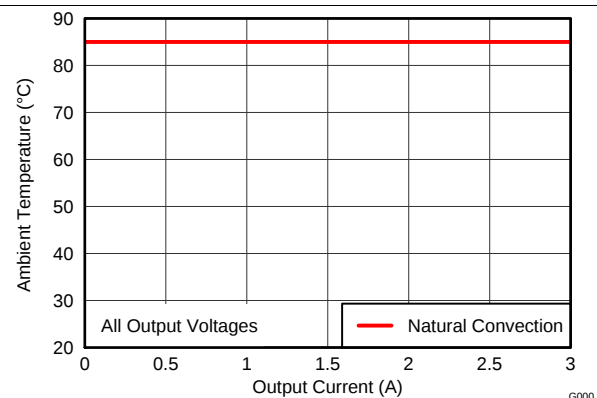


Figure 14. Safe Operating Area

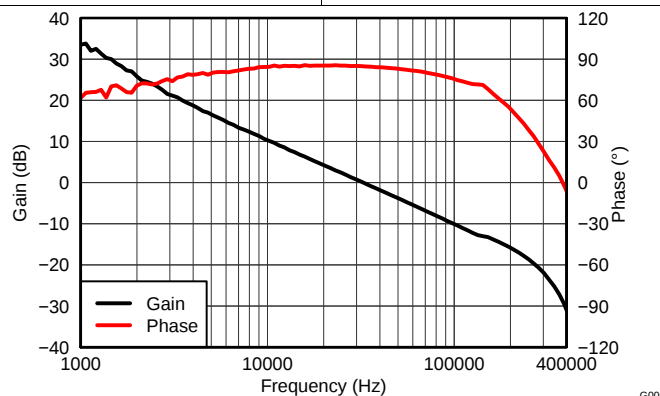


Figure 15. V_{OUT}=2.5 V, I_{OUT}=3 A, C_{OUT1}= 100 μ F ceramic, C_{OUT2}= 100 μ F ceramic, f_{SW}= 480 kHz

- (1) The electrical characteristic data has been developed from actual products tested at 25°C. This data is considered typical for the converter. Applies to [Figure 11](#), [Figure 12](#), and [Figure 13](#).
- (2) The temperature derating curves represent the conditions at which internal components are at or below the manufacturer's maximum operating temperatures. Derating limits apply to devices soldered directly to a 100 mm $\times$ 100 mm double-sided PCB with 1 oz. copper. Applies to [Figure 14](#).

9 Application Information

9.1 Adjusting the Output Voltage

The VADJ control sets the output voltage of the LMZ31503. The output voltage adjustment range is from 0.8V to 5.5V. The adjustment method requires the addition of R_{SET} , which sets the output voltage, the connection of SENSE+ to VOUT, and in some cases R_{RT} which sets the switching frequency. The R_{SET} resistor must be connected directly between the VADJ (pin 43) and AGND (pin 45). The SENSE+ pin (pin 44) must be connected to VOUT either at the load for improved regulation or at VOUT of the module. The R_{RT} resistor must be connected directly between the RT/CLK (pin 35) and AGND (pin 34).

Table 1 gives the standard external R_{SET} resistor for a number of common bus voltages, along with the required R_{RT} resistor for that output voltage. For other output voltages, the value of the required resistor can either be calculated using Equation 1, or selected from the values given in Table 2.

Table 1. Standard R_{SET} Resistor Values for Common Output Voltages

RESISTORS	OUTPUT VOLTAGE V_{OUT} (V)							
	0.8	1.0	1.2	1.5	1.8	2.5	3.3	5.0
R_{SET} (k Ω)	open	5.76	2.87	1.62	1.13	0.665	0.453	0.267
R_{RT} (k Ω)	open	open	324	324	324	324	158	105

$$R_{SET} = \frac{1.43}{\left(\left(\frac{V_{OUT}}{0.8}\right) - 1\right)} \text{ (k}\Omega\text{)} \quad (1)$$

Table 2. Standard R_{SET} Resistor Values

V_{OUT} (V)	R_{SET} (k Ω)	R_{RT} (k Ω)	f_{SW} (kHz)	V_{OUT} (V)	R_{SET} (k Ω)	R_{RT} (k Ω)	f_{SW} (kHz)
0.8	open	open	330	3.2	0.475	191	580
0.9	11.3	open	330	3.3	0.453	158	630
1.0	5.76	open	330	3.4	0.442	158	630
1.1	3.83	open	330	3.5	0.422	158	630
1.2	2.87	324	480	3.6	0.402	158	630
1.3	2.26	324	480	3.7	0.392	158	630
1.4	1.91	324	480	3.8	0.374	137	680
1.5	1.62	324	480	3.9	0.365	137	680
1.6	1.43	324	480	4.0	0.357	137	680
1.7	1.27	324	480	4.1	0.348	137	680
1.8	1.13	324	480	4.2	0.332	118	730
1.9	1.02	324	480	4.3	0.324	118	730
2.0	0.953	324	480	4.4	0.316	118	730
2.1	0.866	324	480	4.5	0.309	118	730
2.2	0.806	324	480	4.6	0.301	118	730
2.3	0.750	324	480	4.7	0.294	118	730
2.4	0.715	324	480	4.8	0.287	105	780
2.5	0.665	324	480	4.9	0.280	105	780
2.6	0.634	237	530	5.0	0.267	105	780
2.7	0.604	237	530	5.1	0.267	105	780
2.8	0.562	237	530	5.2	0.261	105	780
2.9	0.536	237	530	5.3	0.255	105	780
3.0	0.511	191	580	5.4	0.249	105	780
3.1	0.499	191	580	5.5	0.243	105	780

9.2 Capacitor Recommendations for the LMZ31503 Power Supply

9.2.1 Capacitor Technologies

9.2.1.1 Electrolytic, Polymer-Electrolytic Capacitors

When using electrolytic capacitors, high-quality, computer-grade electrolytic capacitors are recommended. Polymer-electrolytic type capacitors are recommended for applications where the ambient operating temperature is less than 0°C. The Sanyo OS-CON capacitor series is suggested due to the lower ESR, higher rated surge, power dissipation, ripple current capability, and small package size. Aluminum electrolytic capacitors provide adequate decoupling over the frequency range of 2 kHz to 150 kHz, and are suitable when ambient temperatures are above 0°C.

9.2.1.2 Ceramic Capacitors

The performance of aluminum electrolytic capacitors is less effective than ceramic capacitors above 150 kHz. Multilayer ceramic capacitors have a low ESR and a resonant frequency higher than the bandwidth of the regulator. They can be used to reduce the reflected ripple current at the input as well as improve the transient response of the output.

9.2.1.3 Tantalum, Polymer-Tantalum Capacitors

Polymer-tantalum type capacitors are recommended for applications where the ambient operating temperature is less than 0°C. The Sanyo POSCAP series and Kemet T530 capacitor series are recommended rather than many other tantalum types due to their lower ESR, higher rated surge, power dissipation, ripple current capability, and small package size. Tantalum capacitors that have no stated ESR or surge current rating are not recommended for power applications.

9.2.2 Input Capacitor

The LMZ31503 requires a minimum input capacitance of 68 μF of ceramic and/or polymer-tantalum capacitors. The ripple current rating of the capacitor must be at least 450 mArms. [Table 5](#) includes a preferred list of capacitors by vendor.

9.2.3 Output Capacitor

The required output capacitance is determined by the output voltage of the LMZ31503. See [Table 3](#) for the amount of required capacitance. The required output capacitance must be comprised of all ceramic capacitors. When adding additional non-ceramic bulk capacitors, low-ESR devices like the ones recommended in [Table 5](#) are required. The required capacitance above the minimum is determined by actual transient deviation requirements. See [Table 4](#) for typical transient response values for several output voltage, input voltage and capacitance combinations. [Table 5](#) includes a preferred list of capacitors by vendor.

Table 3. Required Output Capacitance

V _{OUT} RANGE (V)		MINIMUM REQUIRED C _{OUT} (μF)
MIN	MAX	
0.8	< 1.2	6x 47 μF ceramic
1.2	< 3.0	4x 47 μF ceramic
3.0	< 4.0	2x 47 μF ceramic
4.0	5.5	47 μF ceramic

Table 4. Output Voltage Transient Response

C _{IN1} = 22 µF CERAMIC, C _{IN2} = 68 µF POSCAP, LOAD STEP = 1.5 A, 1 A/µs						
V _{OUT} (V)	PV _{IN} (V)	C _{OUT1} Ceramic	C _{OUT2} BULK	VOLTAGE DEVIATION (mV)	PEAK-PEAK (mV)	RECOVERY TIME (µs)
0.8	5	6x 47 µF	None	25	55	170
		6x 47 µF	330 µF	15	30	160
	12	6x 47 µF	None	20	35	180
		6x 47 µF	330 µF	15	30	170
1.0	5	6x 47 µF	None	20	40	170
		6x 47 µF	330 µF	15	30	170
	12	6x 47 µF	None	20	45	180
		6x 47 µF	330 µF	15	30	170
1.2	5	4x 47 µF	None	30	55	170
		4x 47 µF	220 µF	25	45	170
	12	4x 47 µF	None	30	55	180
		4x 47 µF	220 µF	25	50	170
1.8	5	4x 47 µF	None	35	65	180
		4x 47 µF	220 µF	30	55	180
	12	4x 47 µF	None	35	65	190
		4x 47 µF	220 µF	30	55	180
3.3	5	2x 47 µF	None	65	130	190
		2x 47 µF	100 µF	55	110	190
	12	2x 47 µF	None	65	130	200
		2x 47 µF	100 µF	60	120	200
5.0	12	1x 47 µF	None	100	200	210
		1x 47 µF	100 µF	85	170	210

Table 5. Recommended Input/Output Capacitors⁽¹⁾

VENDOR	SERIES	PART NUMBER	CAPACITOR CHARACTERISTICS		
			WORKING VOLTAGE (V)	CAPACITANCE (µF)	ESR ⁽²⁾ (mΩ)
Murata	X5R	GRM32ER61E226K	16	22	2
TDK	X5R	C3225X5R0J476K	6.3	47	2
Murata	X5R	GRM32ER60J476M	6.3	47	2
Sanyo	POSCAP	16TQC68M	16	68	50
Kemet	T520	T520V107M010ASE025	10	100	25
Sanyo	POSCAP	6TPE100MI	6.3	100	25
Sanyo	POSCAP	2R5TPE220M7	2.5	220	7
Kemet	T530	T530D227M006ATE006	6.3	220	6
Kemet	T530	T530D337M006ATE010	6.3	330	10
Sanyo	POSCAP	2TPF330M6	2.0	330	6
Sanyo	POSCAP	6TPE330MFL	6.3	330	15

(1) Capacitor Supplier Verification

Please verify availability of capacitors identified in this table.

RoHS, Lead-free and Material Details

Please consult capacitor suppliers regarding material composition, RoHS status, lead-free status, and manufacturing process requirements.

(2) Maximum ESR @ 100kHz, 25°C.

9.3 Transient Response

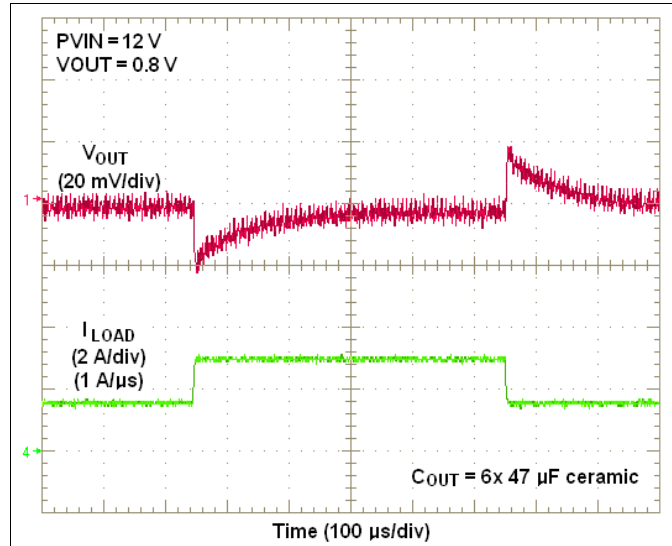


Figure 16. PVIN = 12V, VOUT = 0.8V, 1.5A Load Step

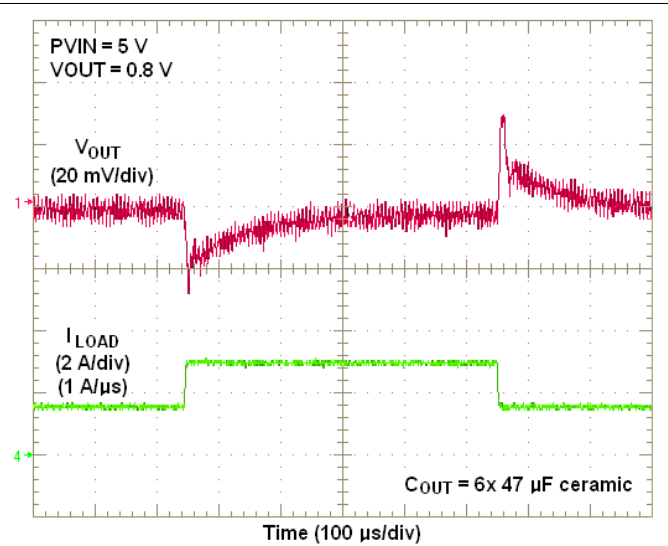


Figure 17. PVIN = 5V, VOUT = 0.8V, 1.5A Load Step

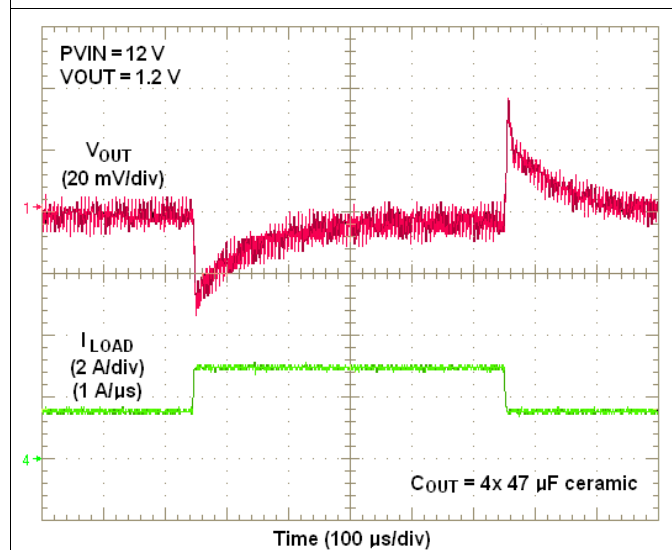


Figure 18. PVIN = 12V, VOUT = 1.2V, 1.5A Load Step

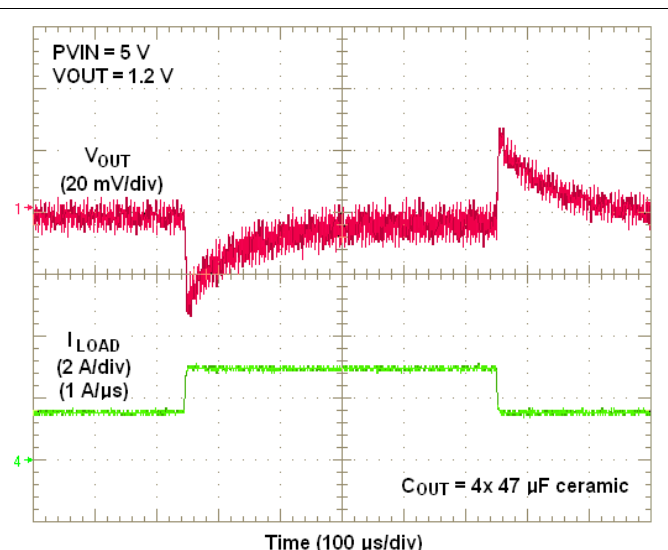
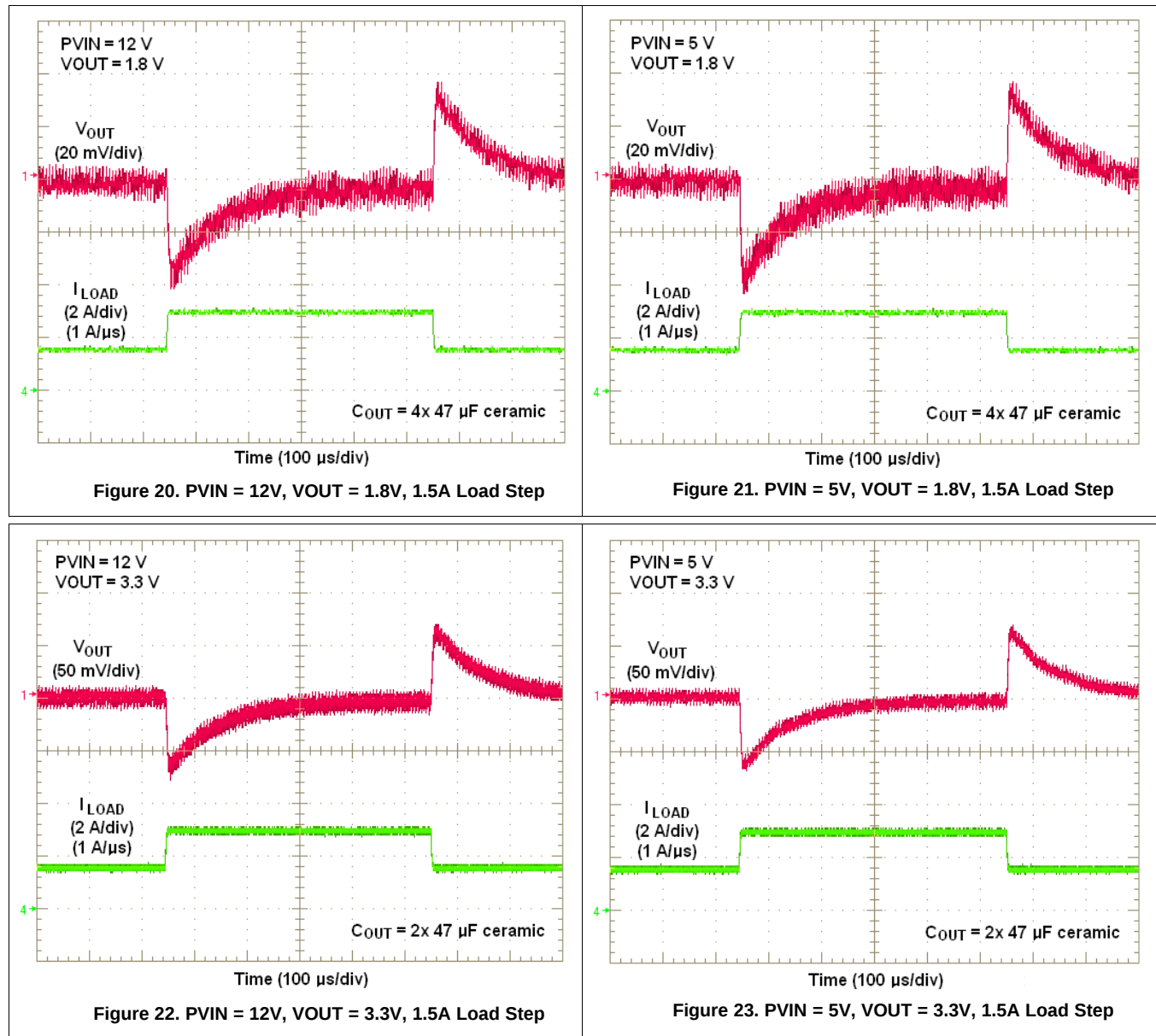


Figure 19. PVIN = 5V, VOUT = 1.2V, 1.5A Load Step

Transient Response (continued)



9.4 Application Schematics

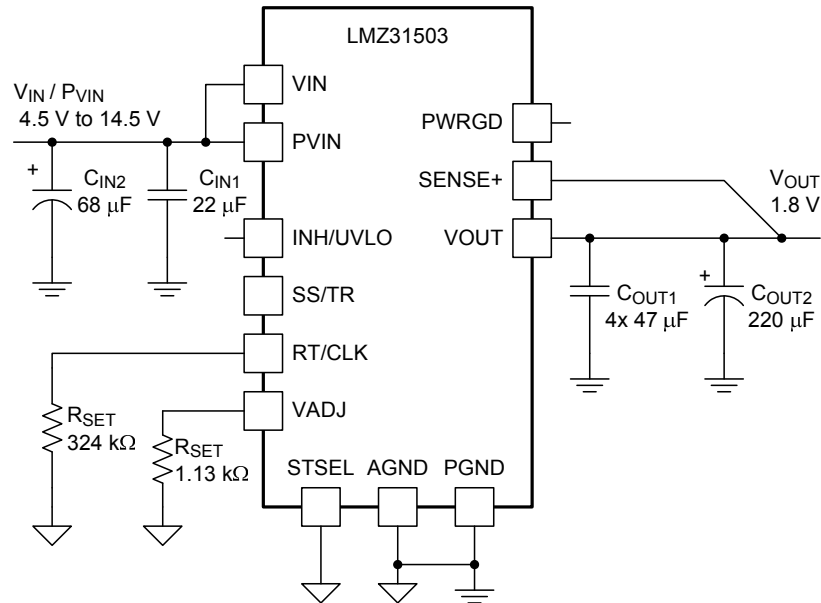


Figure 24. Typical Schematic
PVIN = VIN = 4.5 V to 14.5 V, VOUT = 1.8 V

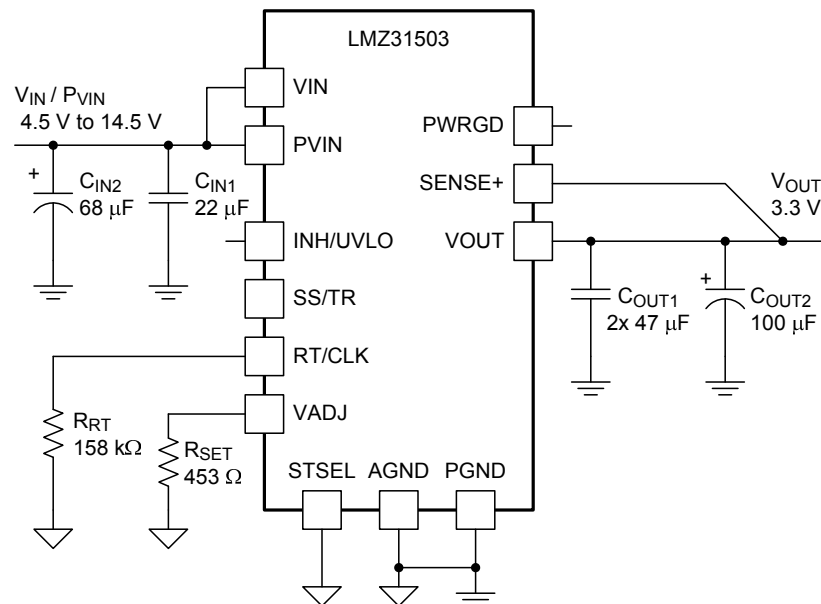


Figure 25. Typical Schematic
PVIN = VIN = 4.5 V to 14.5 V, VOUT = 3.3 V

Application Schematics (continued)

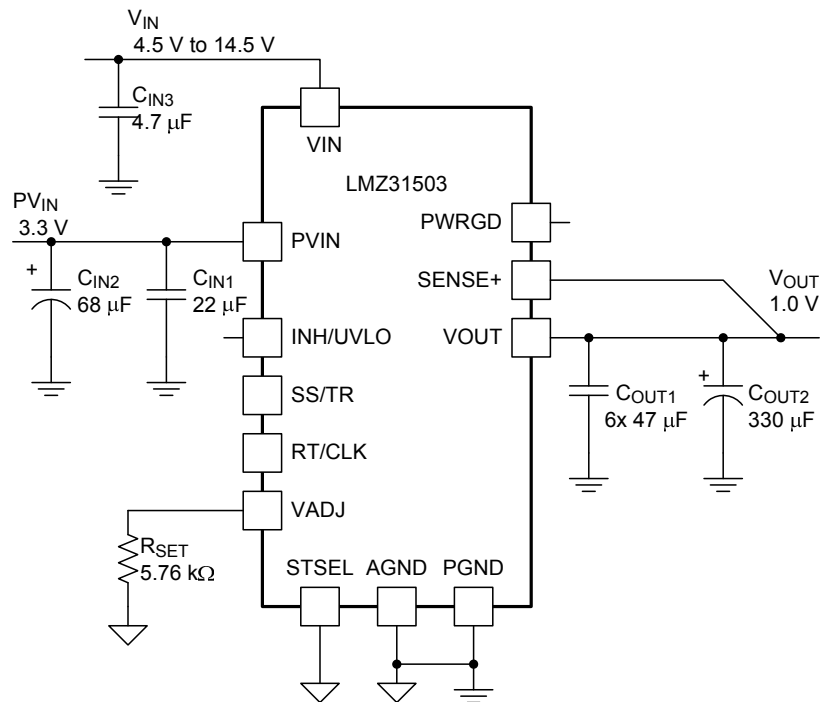


Figure 26. Typical Schematic
PVIN = 3.3 V, V_{IN} = 4.5 V to 14.5 V, V_{OUT} = 1.0 V

9.5 Custom Design With WEBENCH® Tools

[Click here](#) to create a custom design using the LMZ31503 device with the WEBENCH® Power Designer.

1. Start by entering the input voltage (V_{IN}), output voltage (V_{OUT}), and output current (I_{OUT}) requirements.
2. Optimize the design for key parameters such as efficiency, footprint, and cost using the optimizer dial.
3. Compare the generated design with other possible solutions from Texas Instruments.

The WEBENCH Power Designer provides a customized schematic along with a list of materials with real-time pricing and component availability.

In most cases, these actions are available:

- Run electrical simulations to see important waveforms and circuit performance
- Run thermal simulations to understand board thermal performance
- Export customized schematic and layout into popular CAD formats
- Print PDF reports for the design, and share the design with colleagues

Get more information about WEBENCH tools at www.ti.com/WEBENCH.

9.6 VIN and PVIN Input Voltage

The LMZ31503 allows for a variety of applications by using the VIN and PVIN pins together or separately. The VIN voltage supplies the internal control circuits of the device. The PVIN voltage provides the input voltage to the power converter system.

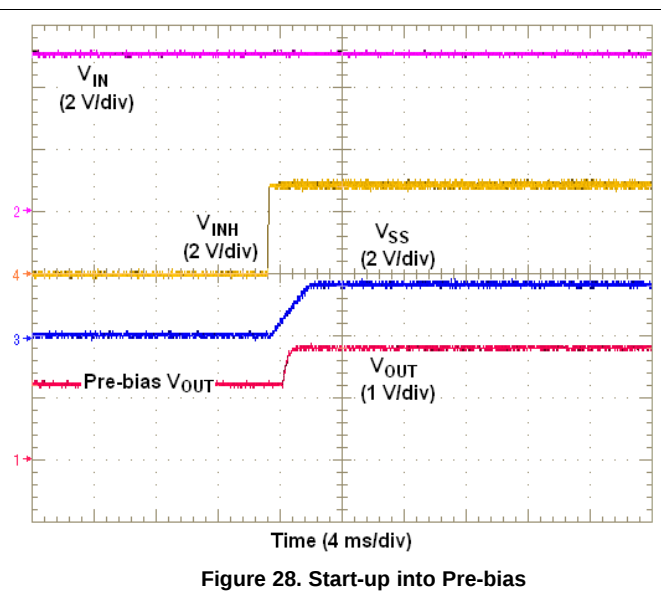
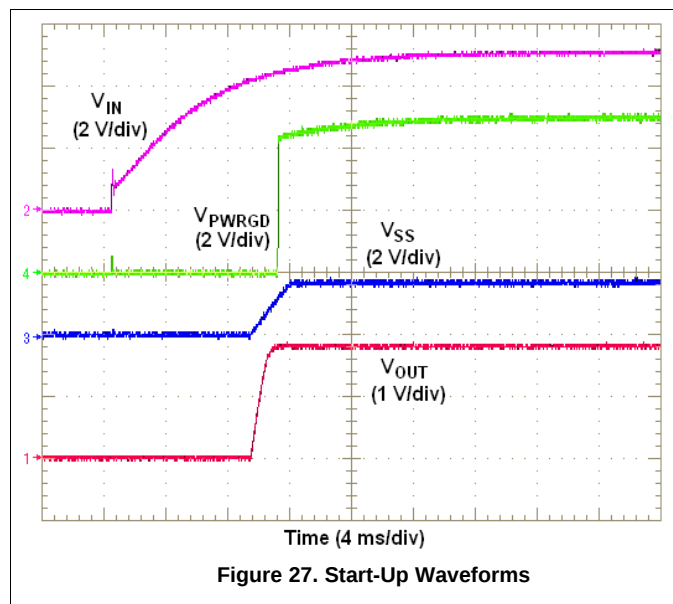
If tied together, the input voltage for the VIN pin and the PVIN pin can range from 4.5 V to 14.5 V. If using the VIN pin separately from the PVIN pin, the VIN pin must be between 4.5 V and 14.5 V, and the PVIN pin can range from as low as 1.6 V to 14.5 V. A voltage divider connected to the INH/UVLO pin can adjust the either input voltage UVLO appropriately. See the [Programmable Undervoltage Lockout \(UVLO\)](#) section of this datasheet for more information.

9.7 Power Good (PWRGD)

The PWRGD pin is an open drain output. Once the voltage on the SENSE+ pin is between 94% and 106% of the set voltage, the PWRGD pin pull-down is released and the pin floats. The recommended pull-up resistor value is between 10 k Ω and 100 k Ω to a voltage source that is 5.5 V or less. The PWRGD pin is in a defined state once VIN is greater than 1.0 V, but with reduced current sinking capability. The PWRGD pin achieves full current sinking capability once the VIN pin is above 4.5V. The PWRGD pin is pulled low when the voltage on SENSE+ is lower than 91% or greater than 109% of the nominal set voltage. Also, the PWRGD pin is pulled low if the input UVLO or thermal shutdown is asserted, the INH pin is pulled low, or the SS/TR pin is below 1.4 V.

9.8 Power-Up Characteristics

When configured as shown in the front page schematic, the LMZ31503 produces a regulated output voltage following the application of a valid input voltage. During the power-up, internal soft-start circuitry slows the rate that the output voltage rises, thereby limiting the amount of in-rush current that can be drawn from the input source. The soft-start circuitry introduces a short time delay from the point that a valid input voltage is recognized. Figure 27 shows the start-up waveforms for a LMZ31503, operating from a 5-V input ($P_{VIN}=V_{IN}$) and with the output voltage adjusted to 1.8 V. Figure 28 shows the start-up waveforms for a LMZ31503 starting up into a pre-biased output voltage. The waveforms were measured with a 2-A constant current load.



9.9 Pre-Biased Start-Up

The LMZ31503 has been designed to prevent discharging a pre-biased output. During monotonic pre-biased startup, the LMZ31503 does not allow current to sink until the SS/TR pin voltage is higher than 1.4 V.

9.10 Remote Sense

The SENSE+ pin must be connected to V_{OUT} at the load, or at the device pins.

Connecting the SENSE+ pin to V_{OUT} at the load improves the load regulation performance of the device by allowing it to compensate for any I-R voltage drop between its output pins and the load. An I-R drop is caused by the high output current flowing through the small amount of pin and trace resistance. This should be limited to a maximum of 300 mV.

NOTE

The remote sense feature is not designed to compensate for the forward drop of nonlinear or frequency dependent components that may be placed in series with the converter output. Examples include OR-ing diodes, filter inductors, ferrite beads, and fuses. When these components are enclosed by the SENSE+ connection, they are effectively placed inside the regulation control loop, which can adversely affect the stability of the regulator.

9.11 Output On/Off Inhibit (INH)

The INH pin provides electrical on/off control of the device. Once the INH pin voltage exceeds the threshold voltage, the device starts operation. If the INH pin voltage is pulled below the threshold voltage, the regulator stops switching and enters low quiescent current state.

The INH pin has an internal pull-up current source, allowing the user to float the INH pin for enabling the device. If an application requires controlling the INH pin, use an open drain/collector device, or a suitable logic gate to interface with the pin.

Figure 29 shows the typical application of the inhibit function. The Inhibit control has its own internal pull-up to VIN potential. An open-collector or open-drain device is recommended to control this input.

Turning Q1 on applies a low voltage to the inhibit control (INH) pin and disables the output of the supply, shown in Figure 30. If Q1 is turned off, the supply executes a soft-start power-up sequence, as shown in Figure 31. A regulated output voltage is produced within 10 ms. The waveforms were measured with a 2-A constant resistance load.

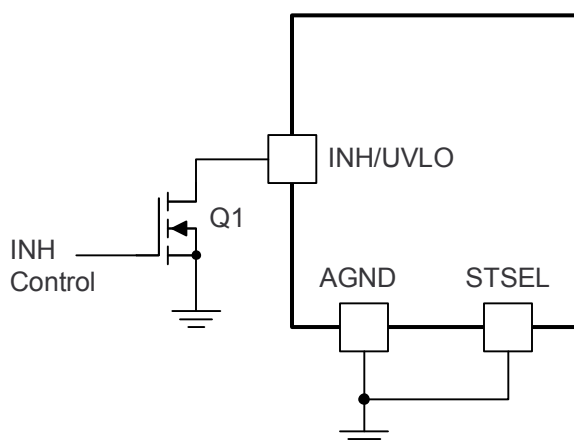
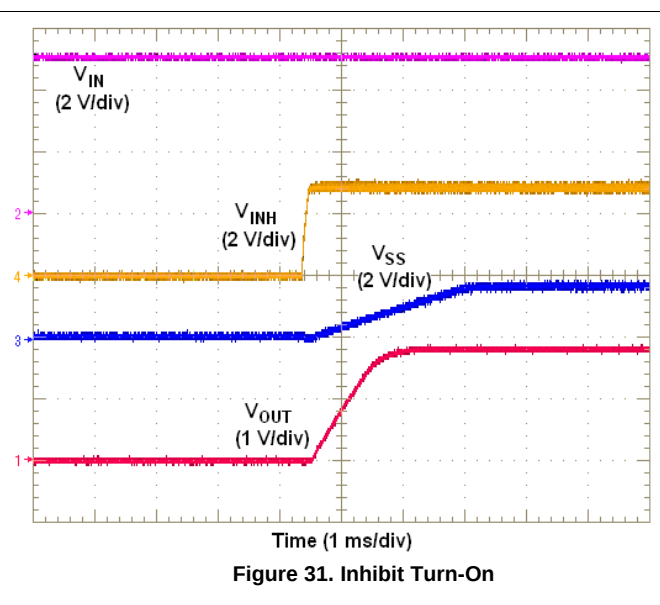
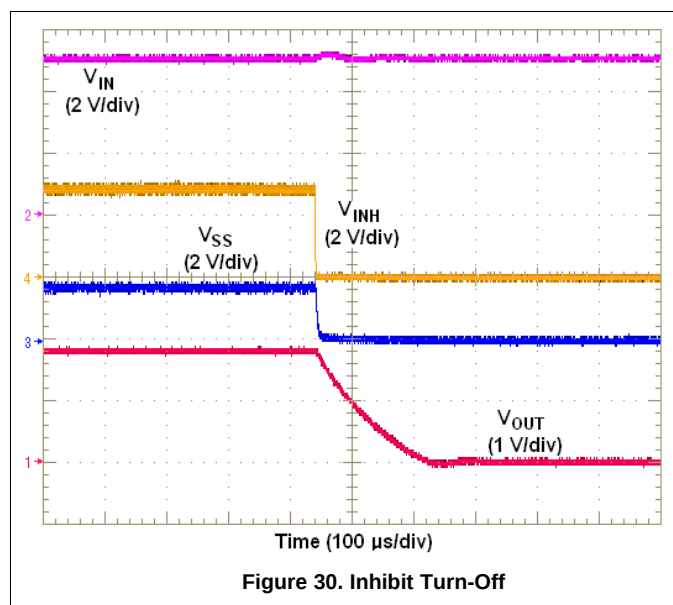


Figure 29. Typical Inhibit Control



9.12 Slow Start (SS/TR)

Connecting the STSEL pin to AGND and leaving SS/TR pin open enables the internal SS capacitor with a slow start interval of approximately 1.1 ms. Adding additional capacitance between the SS pin and AGND increases the slow start time. Table 6 shows an additional SS capacitor connected to the SS/TR pin and the STSEL pin connected to AGND. See Table 6 below for SS capacitor values and timing interval.

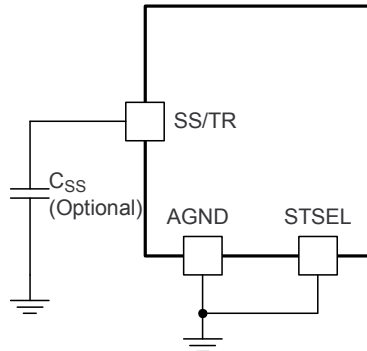


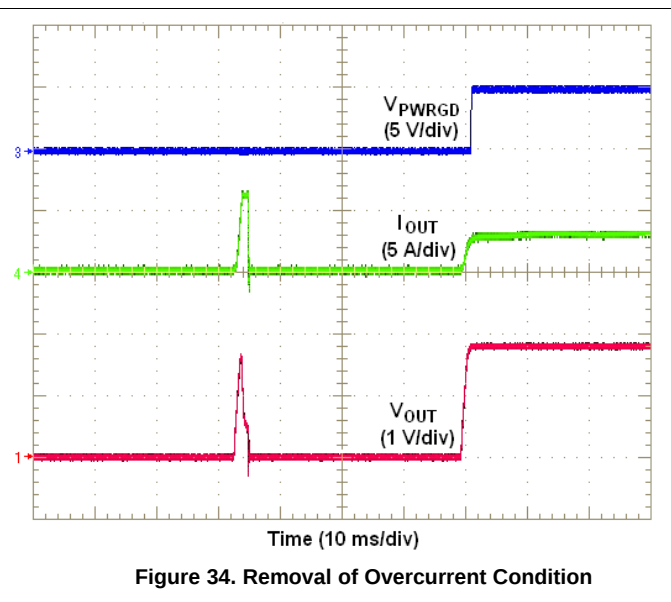
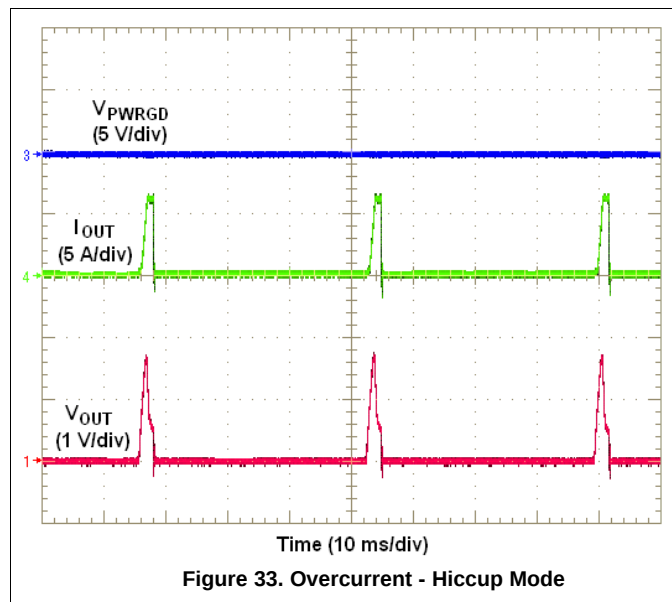
Figure 32. Slow-Start Capacitor (C_{SS}) and STSEL Connection

Table 6. Slow-Start Capacitor Values and Slow-Start Time

C_{SS} (pF)	open	2200	4700	10000	15000	22000	25000
SS Time (msec)	1.1	1.9	2.8	4.6	6.4	8.8	9.8

9.13 Overcurrent Protection

For protection against load faults, the LMZ31503 incorporates output overcurrent protection. Applying a load that exceeds the regulator's overcurrent threshold causes the regulated output to shut down. Following shutdown, the output voltage periodically attempts to recover by initiating a soft-start power-up. This is described as a *hiccup* mode of operation, whereby the module continues in a cycle of successive shutdown and power up until the load fault is removed, as shown in Figure 33. During this period, the average current flowing into the fault is significantly reduced. Once the fault is removed, the module automatically recovers and returns to normal operation, as shown in Figure 34.



9.14 Synchronization (CLK)

An internal phase locked loop (PLL) has been implemented to allow synchronization between 330 kHz and 780 kHz, and to easily switch from RT mode to CLK mode. To implement the synchronization feature, connect a square wave clock signal to the RT/CLK pin with a duty cycle between 20% to 80%. The clock signal amplitude must transition lower than 0.8 V and higher than 2.0 V. The start of the switching cycle is synchronized to the falling edge of RT/CLK pin. In applications where both RT mode and CLK mode are needed, the device can be configured as shown in .

Before the external clock is present, the device works in RT mode and the switching frequency is set by RT resistor (R_{RT}). When the external clock is present, the CLK mode overrides the RT mode. The first time the CLK pin is pulled above the RT/CLK high threshold (2.0 V), the device switches from RT mode to the CLK mode and the RT/CLK pin becomes high impedance as the PLL starts to lock onto the frequency of the external clock. It is not recommended to switch from CLK mode back to RT mode because the internal switching frequency drops to 100 kHz and may shut-down due to internal protection circuits before returning to the switching frequency set by the RT resistor.

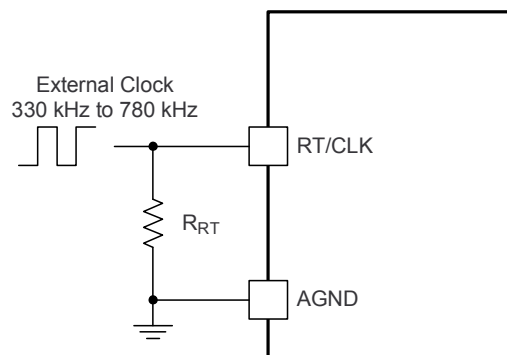


Figure 35. CLK/RT Configuration

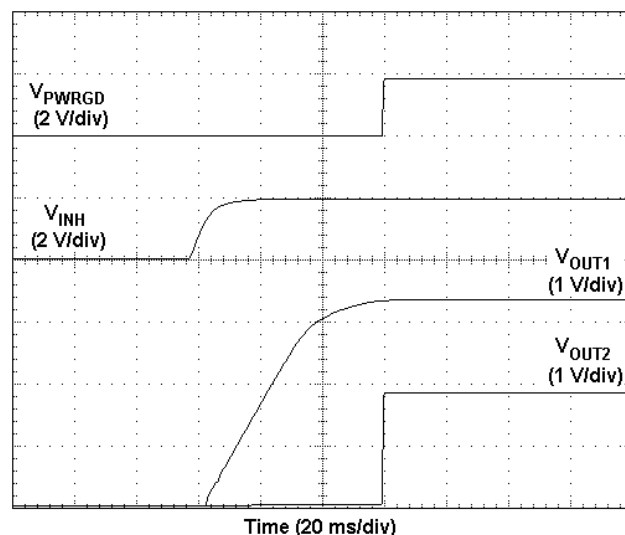
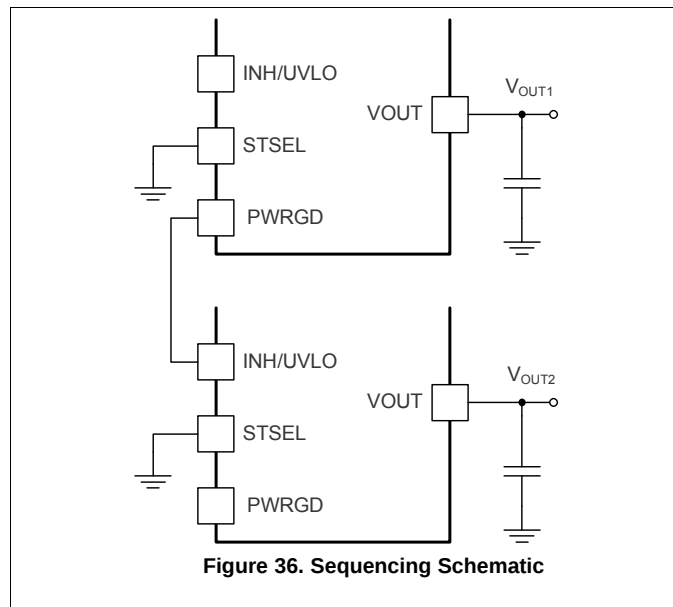
The synchronization frequency must be selected based on the output voltages of the devices being synchronized. Table 7 shows the allowable frequencies for a given range of output voltages. For the most efficient solution, always synchronize to the lowest allowable frequency. For example, an application requires synchronizing three LMZ31503 devices with output voltages of 1.2 V, 1.8 V and 2.5 V, all powered from $P_{VIN} = 12$ V. Table 7 shows that all three output voltages can be synchronized to frequencies between 480 kHz to 630 kHz. For best efficiency, choose 480 kHz as the synchronization frequency.

Table 7. Synchronization Frequency vs Output Voltage

SYNCHRONIZATION FREQUENCY (kHz)	R_{RT} (k Ω)	$P_{VIN} = 12$ V		$P_{VIN} = 5$ V	
		V_{OUT} RANGE (V)		V_{OUT} RANGE (V)	
		MIN	MAX	MIN	MAX
330	OPEN	0.8	1.5	0.8	4.3
380	1000	0.8	1.7		
430	499	0.8	2.1		
480	324	0.9	2.5		
530	237	1.0	2.9		
580	191	1.1	3.2		
630	158	1.2	3.7		
680	137	1.3	4.1		
730	118	1.4	4.7		
780	105	1.5	5.5		

9.15 Sequencing (SS/TR)

Many of the common power supply sequencing methods can be implemented using the SS/TR, INH and PWRGD pins. The sequential method is illustrated in Figure 36 using two LMZ31503 devices. The PWRGD pin of the first device is coupled to the INH pin of the second device which enables the second power supply once the primary supply reaches regulation. Figure 37 shows sequential turn-on waveforms of two LMZ31503 devices.



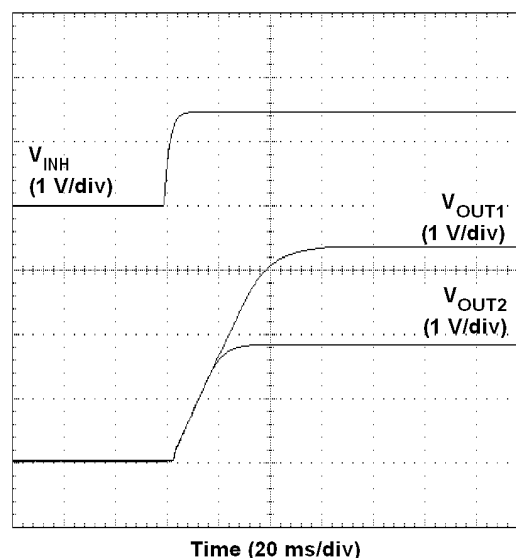
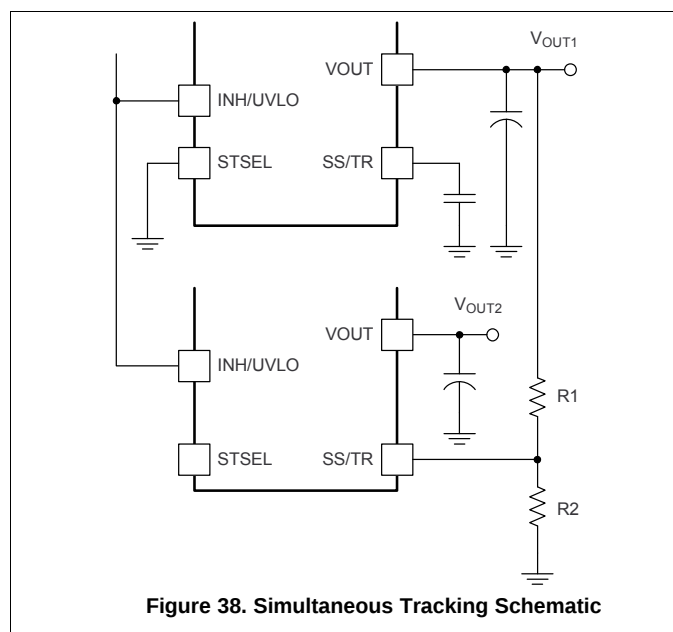
Simultaneous power supply sequencing can be implemented by connecting the resistor network of R1 and R2 shown in Figure 38 to the output of the power supply that needs to be tracked or to another voltage reference source. Figure 39 shows simultaneous turn-on waveforms of two LMZ31503 devices. Use Equation 2 and Equation 3 to calculate the values of R1 and R2.

$$R1 = \frac{(V_{OUT2} \times 12.6)}{0.8} (k\Omega)$$

(2)

$$R2 = \frac{0.8 \times R1}{(V_{OUT2} - 0.8)} (k\Omega)$$

(3)



9.16 Programmable Undervoltage Lockout (UVLO)

The LMZ31503 implements internal UVLO circuitry on the VIN pin. The device is disabled when the VIN pin voltage falls below the internal VIN UVLO threshold. The internal VIN UVLO rising threshold is 4.5 V(max) with a typical hysteresis of 150 mV.

If an application requires either a higher UVLO threshold on the VIN pin or a higher UVLO threshold for a combined VIN and PVIN, then the UVLO pin can be configured as shown in [Figure 40](#) or [Figure 41](#). [Table 8](#) lists standard values for R_{UVLO1} and R_{UVLO2} to adjust the VIN UVLO voltage up.

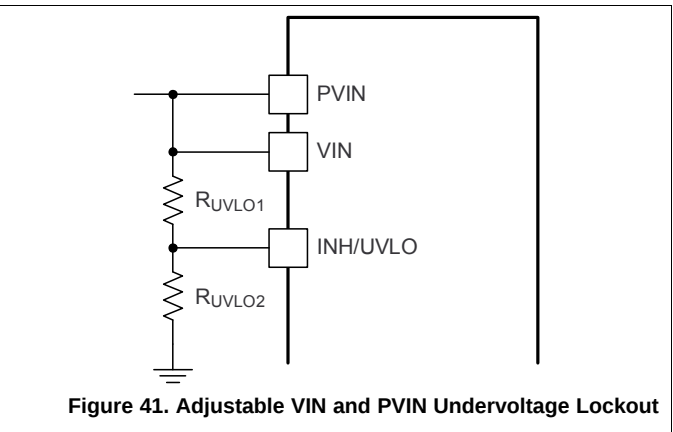
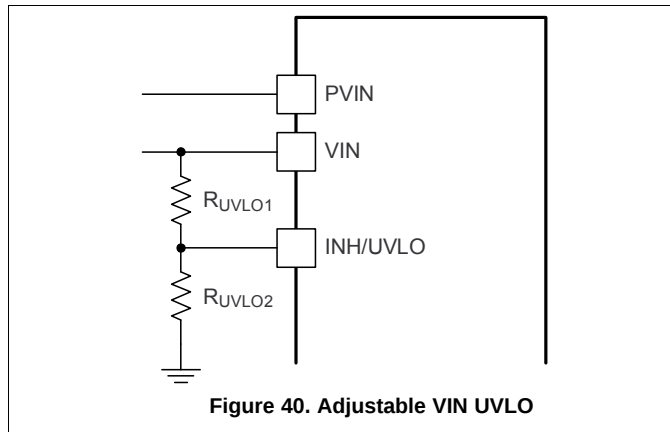


Table 8. Standard Resistor values for Adjusting VIN UVLO

VIN UVLO (V)	5.0	5.5	6.0	6.5	7.0	7.5	8.0	8.5	9.0	9.5	10.0
R_{UVLO1} (k Ω)	68.1	68.1	68.1	68.1	68.1	68.1	68.1	68.1	68.1	68.1	68.1
R_{UVLO2} (k Ω)	21.5	18.7	16.9	15.4	14.0	13.0	12.1	11.3	10.5	9.76	9.31
Hysteresis (mV)	400	415	430	450	465	480	500	515	530	550	565

For a split rail application, if a secondary UVLO on PVIN is required, VIN must be ≥ 4.5 V. [Figure 42](#) shows the PVIN UVLO configuration. Use [Table 9](#) to select R_{UVLO1} and R_{UVLO2} for PVIN. If PVIN UVLO is set for less than 3.0 V, a 5.1-V zener diode should be added to clamp the voltage on the UVLO pin below 6 V.

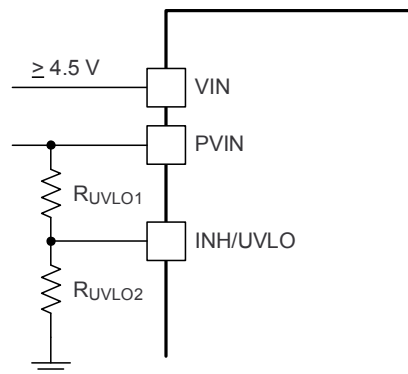


Table 9. Standard Resistor Values for Adjusting PVIN UVLO, (VIN ≥ 4.5 V)

PVIN UVLO (V)	2.0	2.5	3.0	3.5	4.0	4.5	For higher PVIN UVLO voltages see Table UV for resistor values
R_{UVLO1} (k Ω)	68.1	68.1	68.1	68.1	68.1	68.1	
R_{UVLO2} (k Ω)	95.3	60.4	44.2	34.8	28.7	24.3	
Hysteresis (mV)	300	315	335	350	365	385	

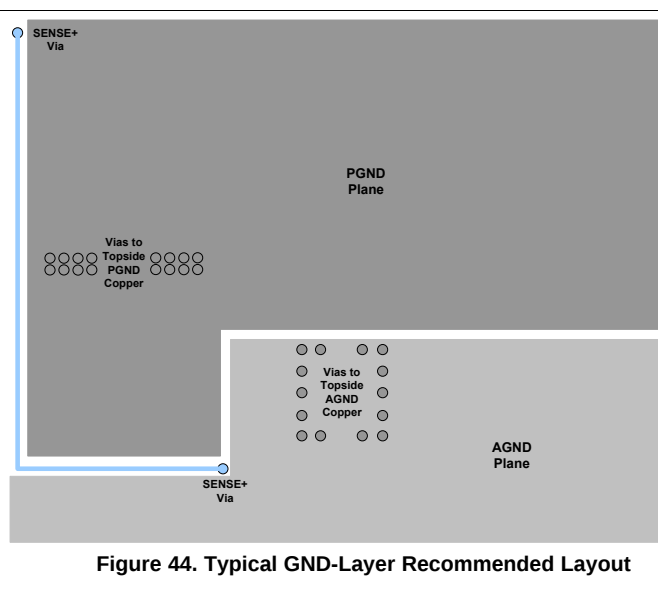
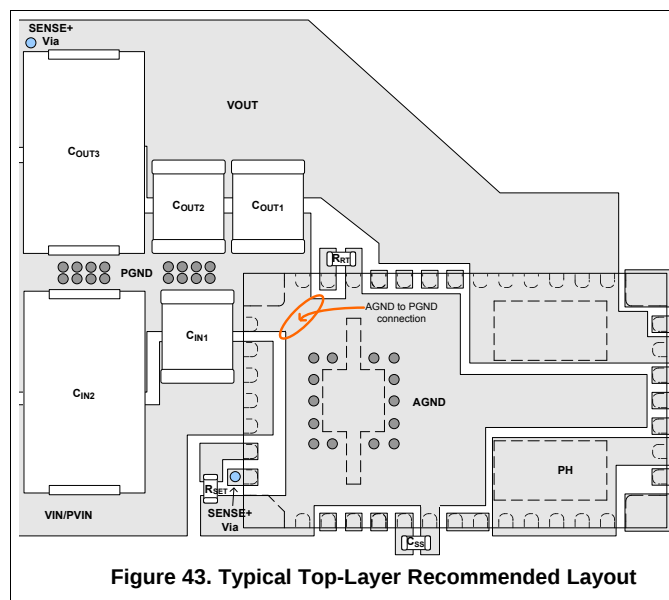
9.17 Thermal Shutdown

The internal thermal shutdown circuitry forces the device to stop switching if the junction temperature exceeds 175°C typically. The device reinitiates the power up sequence when the junction temperature drops below 165°C typically.

9.18 Layout Considerations

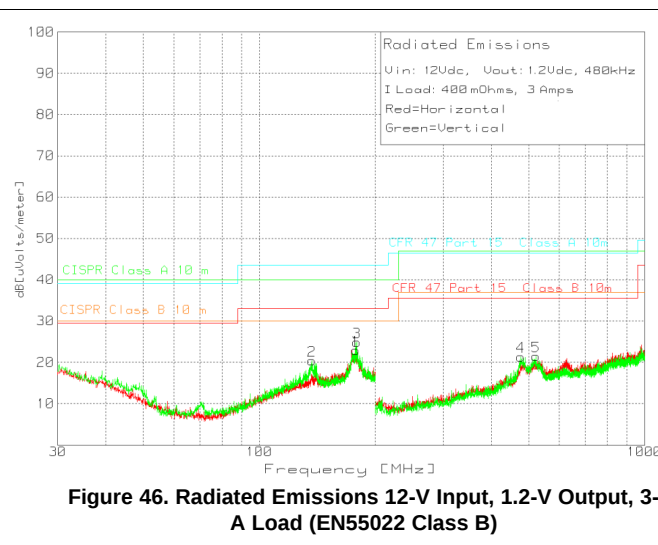
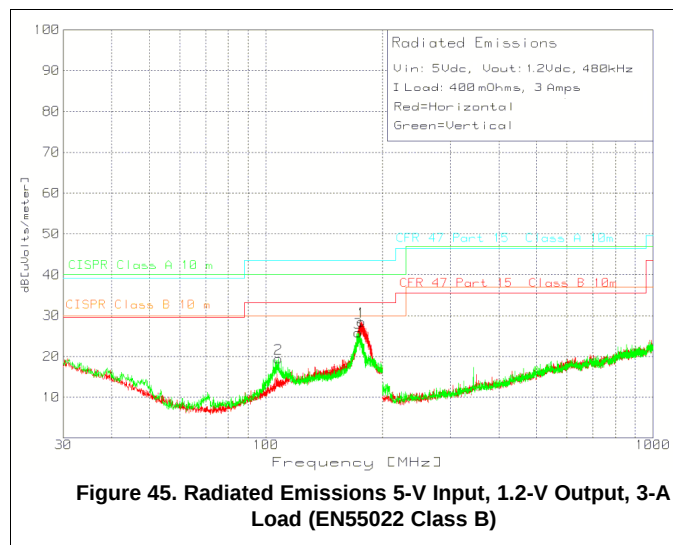
To achieve optimal electrical and thermal performance, an optimized PCB layout is required. Figure 43 and Figure 44 show two layers of a typical PCB layout. Some considerations for an optimized layout are:

- Use large copper areas for power planes (VIN, VOUT, and PGND) to minimize conduction loss and thermal stress.
- Place ceramic input and output capacitors close to the module pins to minimize high frequency noise.
- Locate additional output capacitors between the ceramic capacitor and the load.
- Place a dedicated AGND copper area beneath the LMZ31503.
- Isolate the PH copper area from the VOUT copper area using the AGND copper area.
- Connect the AGND and PGND copper area at one point; near the output capacitors.
- Place R_{SET} , R_{RT} , and C_{SS} as close as possible to their respective pins.
- Use multiple vias to connect the power planes to internal layers.



9.19 EMI

The LMZ31503 is compliant with EN55022 Class B radiated emissions. Figure 45 and Figure 46 show typical examples of radiated emissions plots for the LMZ31503 operating from 5V and 12V respectively. Both graphs include the plots of the antenna in the horizontal and vertical positions.



10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (June 2017) to Revision B	Page
• 添加 LMZ31503 的 WEBENCH® 设计链接	1
• Increased the peak reflow temperature and maximum number of reflows to JEDEC specifications for improved manufacturability	2
• 添加器件支持 部分	28
• 添加机械、封装和可订购信息 部分	29
Changes from Original (July 2013) to Revision A	Page
• Added peak reflow and maximum number of reflows information	2

11 器件和文档支持

11.1 器件支持

11.1.1 开发支持

11.1.1.1 使用 WEBENCH® 工具创建定制设计

单击[此处](#)，使用 LMZ31503 器件并借助 WEBENCH® 电源设计器创建定制设计方案。

1. 首先键入输入电压 (V_{IN})、输出电压 (V_{OUT}) 和输出电流 (I_{OUT}) 要求。
2. 使用优化器拨盘优化关键参数设计，如效率、封装和成本。
3. 将生成的设计与德州仪器 (TI) 的其他解决方案进行比较。

WEBENCH 电源设计器可提供定制原理图以及罗列实时价格和组件供货情况的物料清单。

在多数情况下，可执行以下操作：

- 运行电气仿真，观察重要波形以及电路性能
- 运行热性能仿真，了解电路板热性能
- 将定制原理图和布局方案导出至常用 CAD 格式
- 打印设计方案的 PDF 报告并与同事共享

有关 WEBENCH 工具的详细信息，请访问 www.ti.com.cn/WEBENCH。

11.2 文档支持

11.2.1 相关文档

请参阅如下相关文档：

[BQFN 封装的焊接要求](#)

11.3 接收文档更新通知

要接收文档更新通知，请导航至 TI.com.cn 上的器件产品文件夹。单击右上角的[通知我](#)进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

11.4 社区资源

下列链接提供到 TI 社区资源的连接。链接的内容由各个分销商“按照原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的 [《使用条款》](#)。

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设计支持 **TI 参考设计支持** 可帮助您快速查找有帮助的 E2E 论坛、设计支持工具以及技术支持的联系信息。

11.5 商标

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11.6 静电放电警告



ESD 可能会损坏该集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理措施和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

11.7 术语表

[SLYZ022](#) — TI 术语表。

这份术语表列出并解释术语、缩写和定义。

12 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更，恕不另行通知，且不会对此文档进行修订。如需获取此数据表的浏览器版本，请参阅左侧的导航栏。

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
LMZ31503RUQR	Active	Production	B1QFN (RUQ) 47	500 LARGE T&R	Exempt	NIPDAU	Level-3-245C-168 HR	-40 to 85	LMZ31503
LMZ31503RUQR.A	Active	Production	B1QFN (RUQ) 47	500 LARGE T&R	Exempt	NIPDAU	Level-3-245C-168 HR	-40 to 85	LMZ31503
LMZ31503RUQR.B	Active	Production	B1QFN (RUQ) 47	500 LARGE T&R	Exempt	NIPDAU	Level-3-245C-168 HR	-40 to 85	LMZ31503
LMZ31503RUQT	Active	Production	B1QFN (RUQ) 47	250 SMALL T&R	Exempt	NIPDAU	Level-3-245C-168 HR	-40 to 85	LMZ31503
LMZ31503RUQT.A	Active	Production	B1QFN (RUQ) 47	250 SMALL T&R	Exempt	NIPDAU	Level-3-245C-168 HR	-40 to 85	LMZ31503
LMZ31503RUQT.B	Active	Production	B1QFN (RUQ) 47	250 SMALL T&R	Exempt	NIPDAU	Level-3-245C-168 HR	-40 to 85	LMZ31503
LMZ31503RUQTG4.A	Active	Production	B1QFN (RUQ) 47	250 SMALL T&R	Yes	NIPDAU	Level-3-245C-168 HR	-40 to 85	LMZ31503
LMZ31503RUQTG4.B	Active	Production	B1QFN (RUQ) 47	250 SMALL T&R	Yes	NIPDAU	Level-3-245C-168 HR	-40 to 85	LMZ31503

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TAPE AND REEL INFORMATION


*All dimensions are nominal

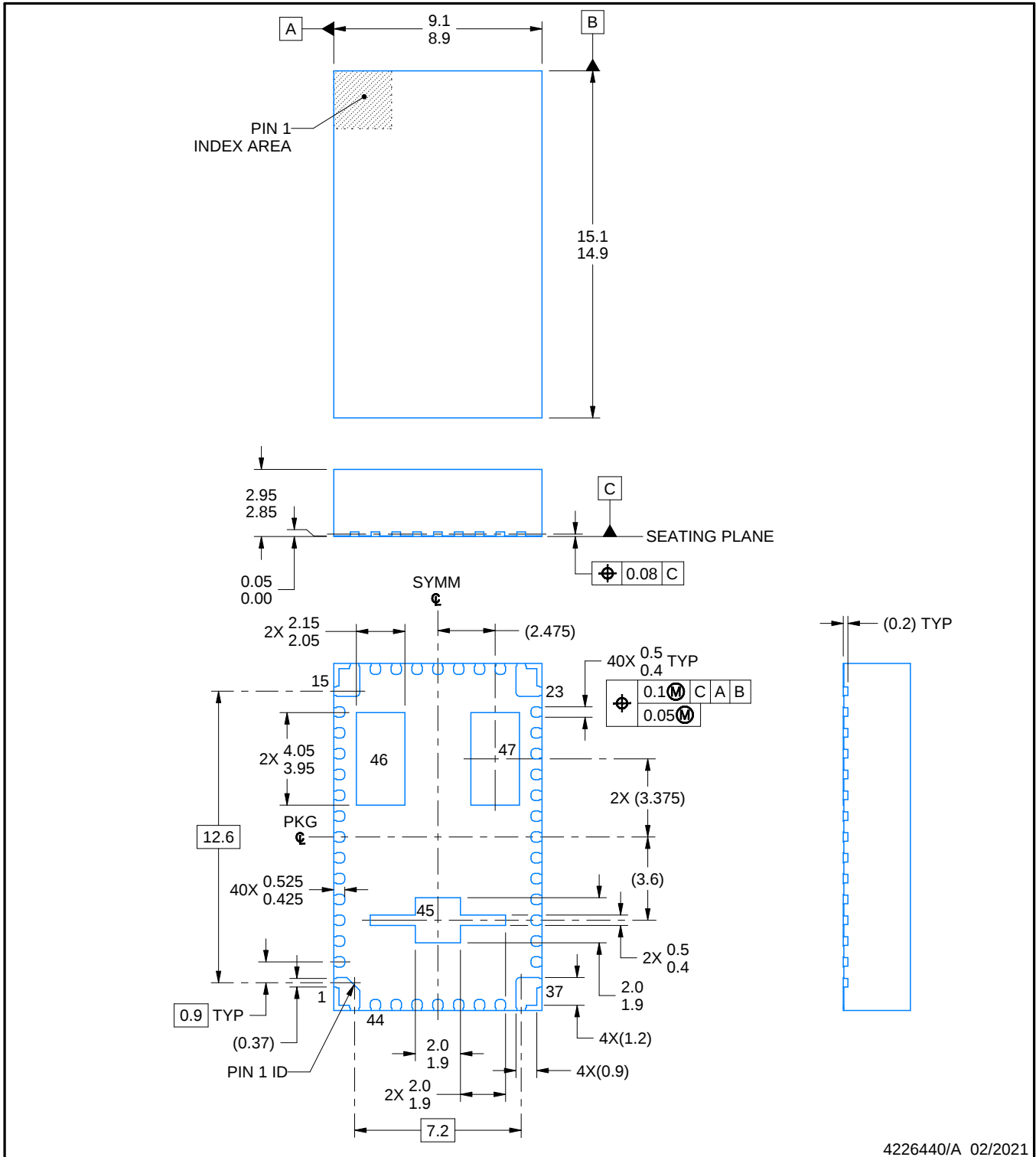
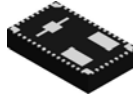
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMZ31503RUQR	B1QFN	RUQ	47	500	330.0	24.4	9.35	15.35	3.1	16.0	24.0	Q1
LMZ31503RUQT	B1QFN	RUQ	47	250	330.0	24.4	9.35	15.35	3.1	16.0	24.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LMZ31503RUQR	B1QFN	RUQ	47	500	383.0	353.0	58.0
LMZ31503RUQT	B1QFN	RUQ	47	250	383.0	353.0	58.0



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NOTES:

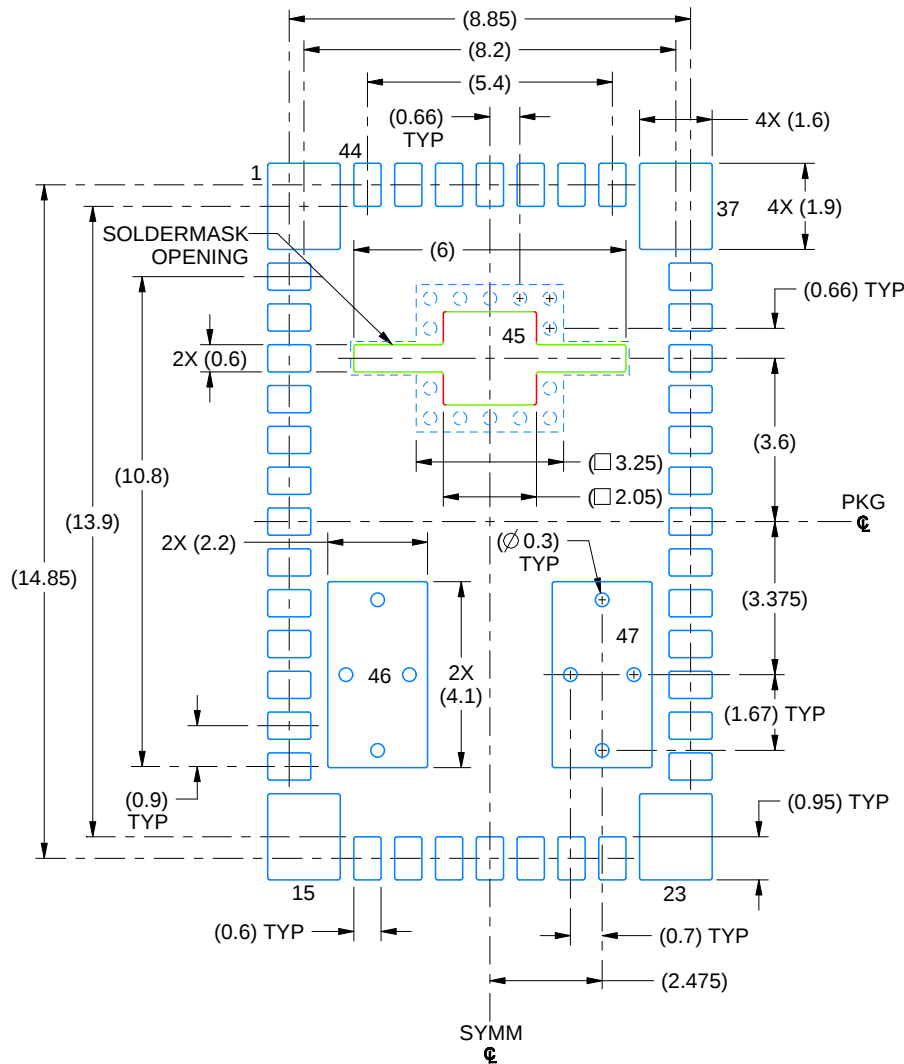
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pads must be soldered to the printed circuit board for optimal thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

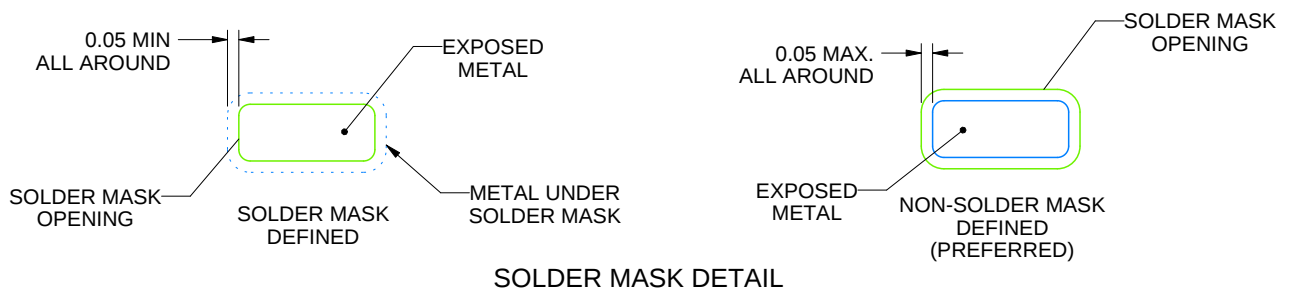
RUQ0047A

B1QFN - 2.95 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:6X



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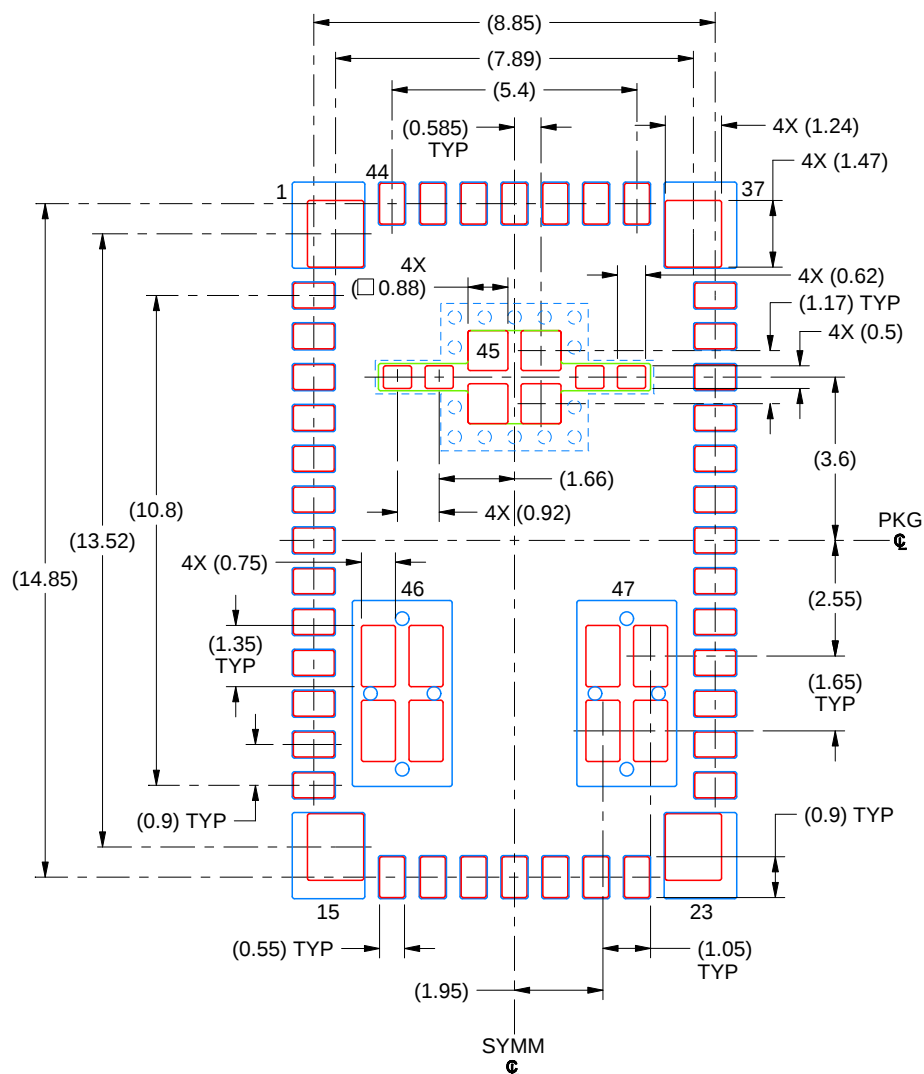
NOTES: (continued)

4. This package designed to be soldered to a thermal pads on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slue271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

RUQ0047A

B1QFN - 2.95 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE

BASED ON 0.1 mm STENCIL THICKNESS

CORNER PINS 1, 15, 23 & 37:

60% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

EXPOSED PAD 45:

66% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

EXPOSED PAD 46 & 47:

45% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

SCALE:6X

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NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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